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TEST REPORT

Test report no.: 1-2970/16-01-08



DAkkS
Deutsche
Akkreditierungsstelle
D-PL-12076-01-01

Testing laboratory

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01

Applicant

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Manufacturer

FLIR Systems AB

Antennvägen 6

187 66 Täby / SWEDEN

Test standard/s

47 CFR Part 15

Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 247 Issue 2

Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

RSS - Gen Issue 4

Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:

Thermal imaging camera

Model name:

FLIR-T8210

FCC ID:

ZLV-FLIRT8210

IC:

5306A-FLIRT8210

Frequency:

DTS band 2400 MHz to 2483.5 MHz

Technology tested:

Bluetooth® +EDR

Antenna:

Integrated PIFA antenna

Power supply:

3.65 V DC by LiOn battery

Temperature range:

-20°C to +55°C



This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

Stefan Bös
Lab Manager
Radio Communications & EMC

Test performed:

Mihail Dorongovskij
Lab Manager
Radio Communications & EMC

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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2.2 Application details

Date of receipt of order:	2017-01-20
Date of receipt of test item:	2017-03-13
Start of test:	2017-03-13
End of test:	2017-03-17
Person(s) present during the test:	Mr. Göran Skedung

2.3 Test laboratories sub-contracted

None

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15	-/-	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	February 2017	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature :	T _{nom}	+23 °C during room temperature tests
	T _{max}	No tests under extreme temperature conditions required!
	T _{min}	No tests under extreme temperature conditions required!
Relative humidity content :		35 %
Barometric pressure :		1021 hpa
Power supply :	V _{nom}	3.65 V DC by LiOn battery
	V _{max}	No tests under extreme voltage conditions required!
	V _{min}	No tests under extreme voltage conditions required!

5 Test item

5.1 General description

Kind of test item :	Thermal imaging camera
Type identification :	FLIR-T8210
HMN :	-/-
PMN :	T530, T540, T850 and T860
HVIN :	FLIR-T8210
FVIN :	-/-
S/N serial number :	Radiated unit: 79100425 Conducted unit: 79100421
HW hardware status :	1
SW software status :	RF test mode
Frequency band :	DTS band 2400 MHz to 2483.5 MHz (lowest channel 2402 MHz; highest channel 2480 MHz)
Type of radio transmission :	FHSS
Use of frequency spectrum :	
Type of modulation :	GFSK, Pi/4 QPSK, 8 DPSK
Number of channels :	79
Antenna :	Integrated PIFA antenna
Power supply :	3.65 V DC by LiOn battery
Temperature range :	-20°C to +55°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report:

1-2970/16-01-10_AnnexA
1-2970/16-01-10_AnnexB
1-2970/16-01-10_AnnexD

6 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

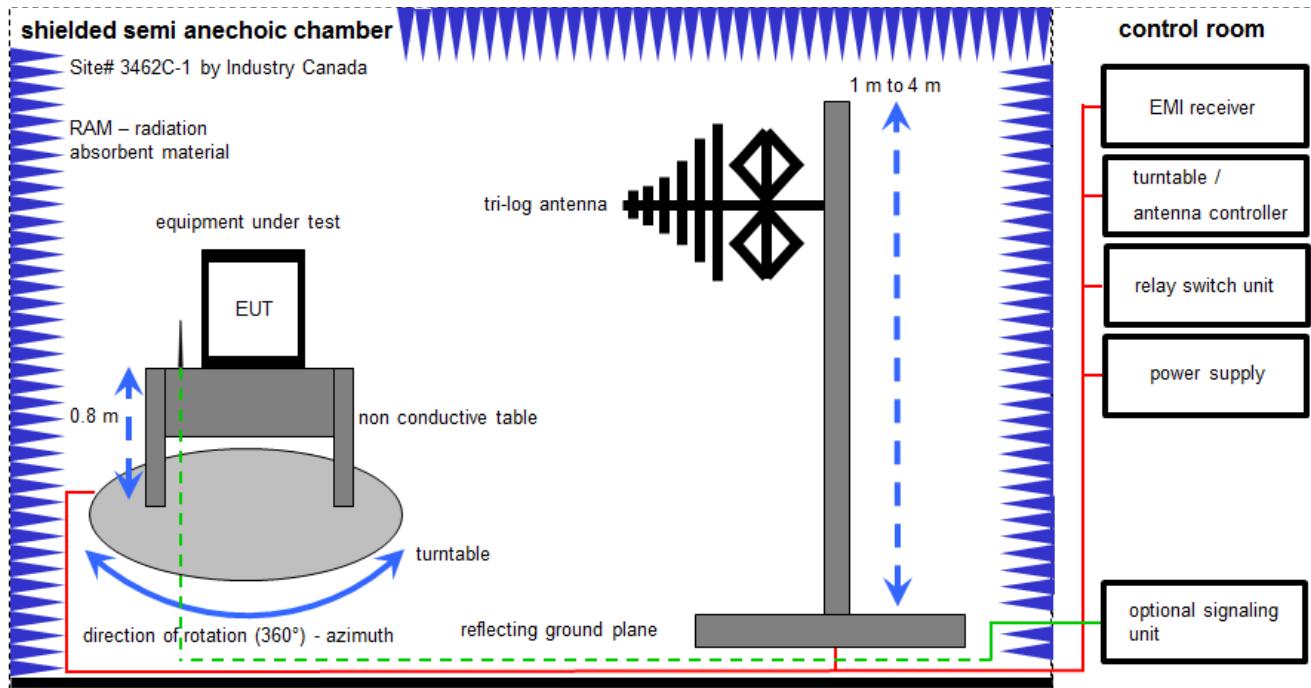
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
Vlk!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

6.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

FS = UR + CL + AF
 (FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

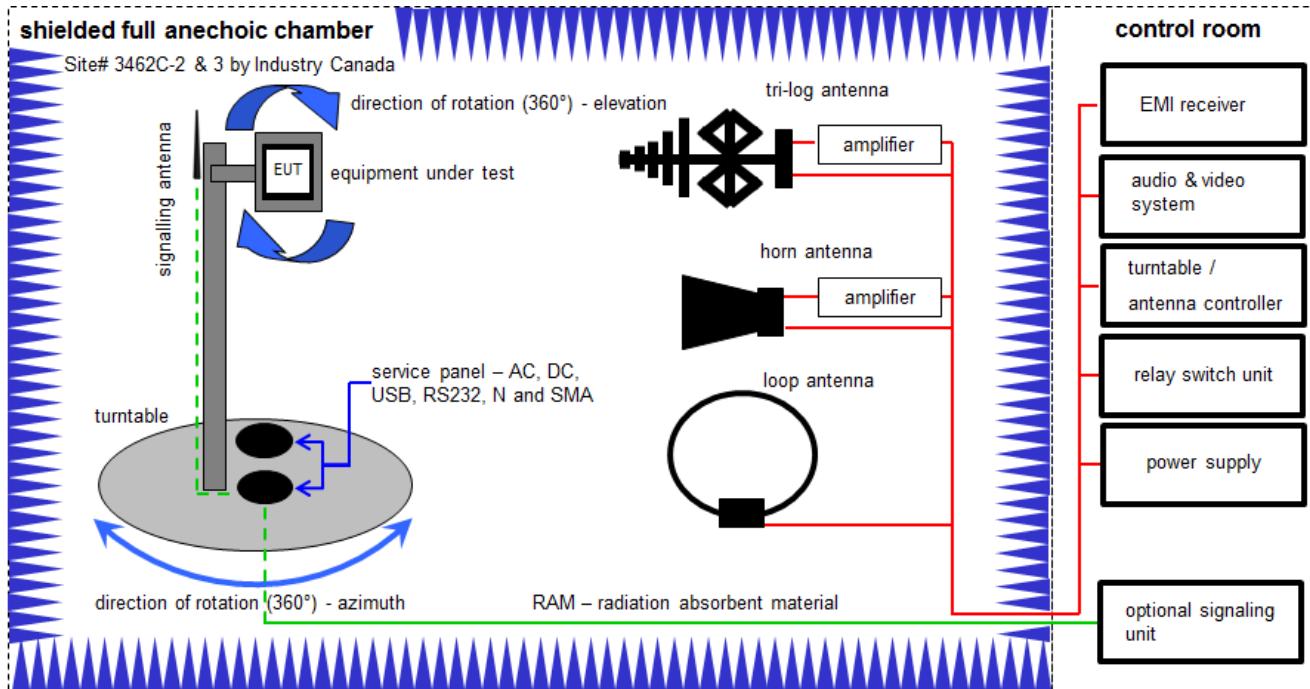
Example calculation:

$$\text{FS [dB}\mu\text{V/m]} = 12.35 \text{ [dB}\mu\text{V/m]} + 1.90 \text{ [dB]} + 16.80 \text{ [dB/m]} = 31.05 \text{ [dB}\mu\text{V/m]} (35.69 \mu\text{V/m})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	01.02.2017	31.01.2018
3	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
4	A	Analyser-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	02.02.2018	02.02.2020
5	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
6	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
7	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	25.04.2016	25.04.2018
8	A	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.2 Shielded fully anechoic chamber



Measurement distance: tri-log antenna and horn antenna 3 meter; loop antenna 3 meter

FS = UR + CA + AF

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

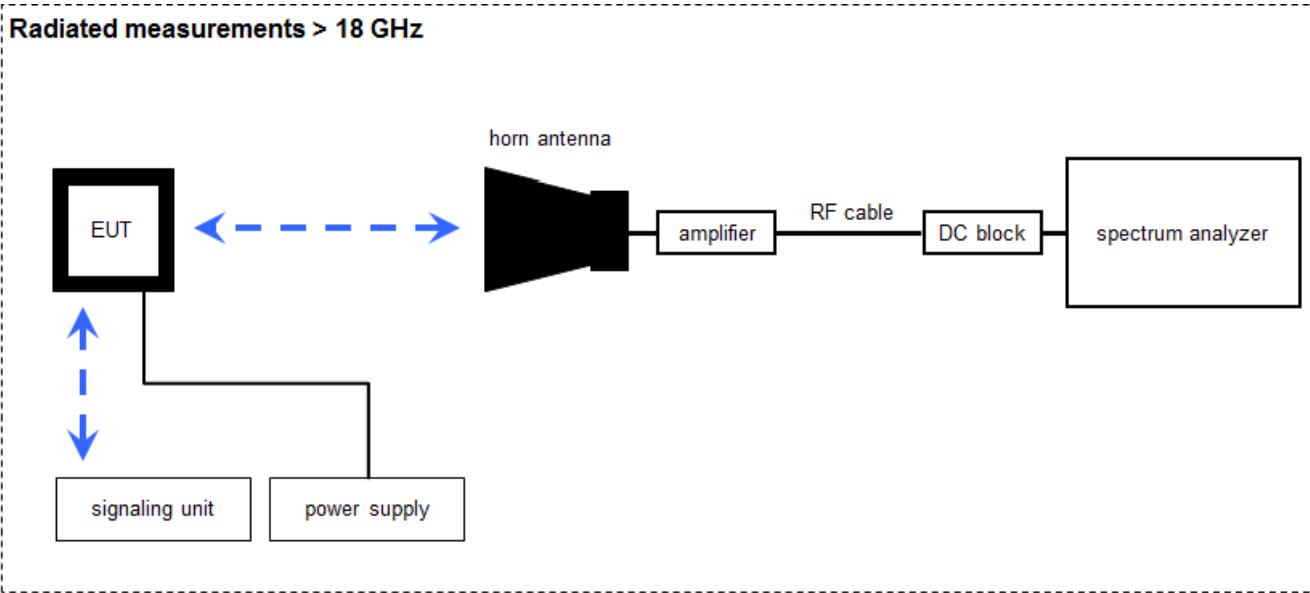
Example calculation:

$$\text{FS [dB}\mu\text{V/m]} = 40.0 \text{ [dB}\mu\text{V/m]} + (-35.8) \text{ [dB]} + 32.9 \text{ [dB/m]} = 37.1 \text{ [dB}\mu\text{V/m]} (71.61 \mu\text{V/m})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A, B	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	v IKI!	20.05.2015	20.05.2017
2	A, B, C	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
	A, B, C	Switch / Control Unit	3488A	HP	*	300000199	ne	-/-	-/-
3	C	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
4	B	Band Reject filter	WRCG2400/2483-2375/2505-50/10SS	Wainwright	11	300003351	ev	-/-	-/-
5	A, B, C	EMI Test Receiver 20Hz- 26,5GHz	ESU26	R&S	100037	300003555	k	31.01.2017	30.01.2018
6	B	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
7	A, B	Broadband Amplifier 0.5-18 GHz	CBLU5184540	CERNEX	22049	300004481	ev	-/-	-/-
8	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-
9	A, B, C	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.3 Radiated measurements > 18 GHz



Measurement distance: horn antenna 50 cm

$$FS = U_R + CA + AF$$

(FS-field strength; U_R -voltage at the receiver; CA-loss signal path & distance correction; AF-antenna factor)

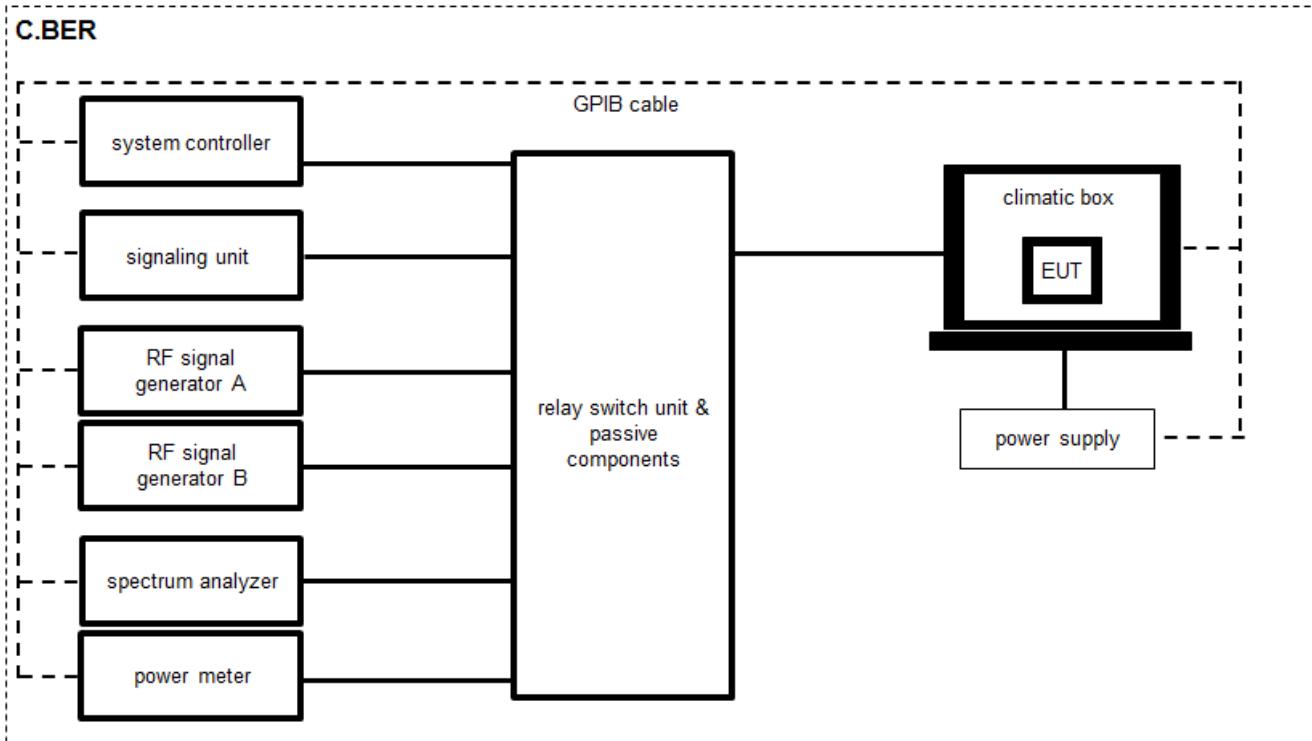
Example calculation:

$$FS [dB\mu V/m] = 40.0 [dB\mu V/m] + (-60.1) [dB] + 36.74 [dB/m] = 16.64 [dB\mu V/m] (6.79 \mu V/m)$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	-/-	300000486	k	10.09.2015	10.09.2017
2	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	25.01.2017	24.01.2018
3	A	Amplifier 2-40 GHz	JS32-02004000-57-5P	MITEQ	1777200	300004541	ev	-/-	-/-
4	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
5	A	RF-Cable	ST18/SMAm/SMm/48	Huber & Suhner	Batch no. 127377	400001183	ev	-/-	-/-
6	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	Batch no. 127377	400001185	ev	-/-	-/-
7	A	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

6.4 Conducted measurements C.BER system



OP = AV + CA
 (OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:

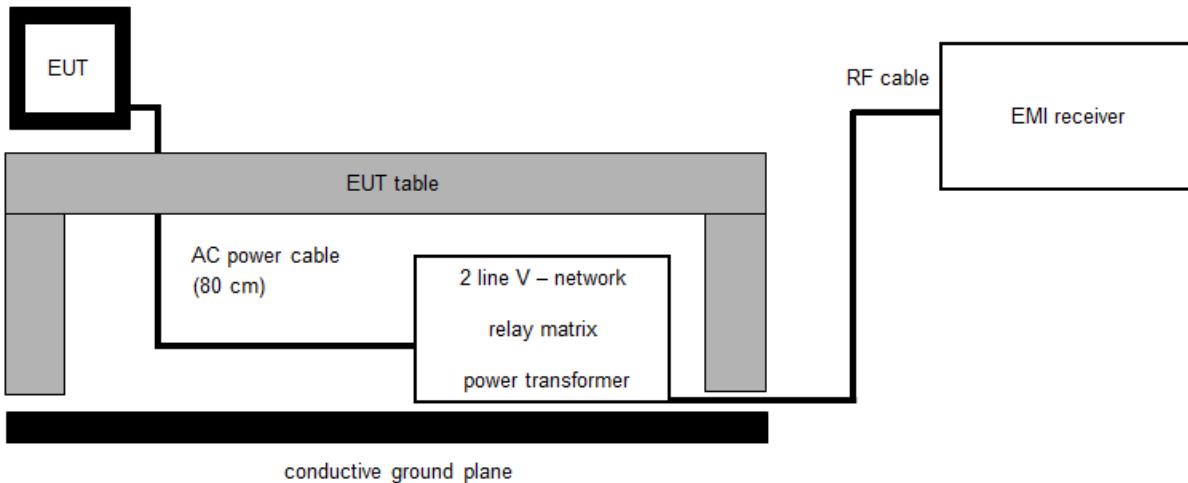
$$\text{OP [dBm]} = 6.0 \text{ [dBm]} + 11.7 \text{ [dB]} = 17.7 \text{ [dBm]} (58.88 \text{ mW})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch / Control Unit	3488A	HP		300000929	ne	-/-	-/-
2	A	CBT (Bluetooth Tester + EDR Signalling)	CBT 1153.9000K35	R&S	100185	300003416	vIKI!	10.02.2019	09.02.2019
3	A	USB/GPIB interface	82357B	Agilent Technologies	MY52103346	300004390	ne	-/-	-/-
4	A	Signal Analyzer 30GHz	FSV30	R&S	103170	300004855	k	30.01.2017	29.01.2019
5	A	USB-GPIB-Interface	82357B	Agilent Technologies	103170	300004852	ne	-/-	-/-
6	A	Power Sensor	NRP-Z81	R&S	100010	300003780	k	27.01.2017	26.01.2019
7	A	Directional Coupler	101020010	Krytar	70215	300002840	ev	-/-	-/-
8	A	DC-Blocker	8143	Inmet Corp.	none	300002842	ne	-/-	-/-
9	A	Powersplitter	6005-3	Inmet Corp.	none	300002841	ev	-/-	-/-
10	A	Messplatzrechner	Tecline	F+W	none	300003580	ne	-/-	-/-
11	A	RF-Cable	ST18/SMAm/SMAm/72	Huber & Suhner	Batch no. 605505	400001187	ev	-/-	-/-
12	A	RF-Cable	Sucoflex 104	Huber & Suhner	147636/4	400001188	ev	-/-	-/-

6.5 AC conducted

AC conducted



FS = UR + CF + VC

(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

$$\text{FS [dB}\mu\text{V/m]} = 37.62 \text{ [dB}\mu\text{V/m]} + 9.90 \text{ [dB]} + 0.23 \text{ [dB]} = 47.75 \text{ [dB}\mu\text{V/m]} (244.06 \mu\text{V/m})$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	893045/004	300000584	k	31.01.2017	30.01.2018
2	A	RF-Filter-section	85420E	HP	3427A00162	300002214	ne	-/-	-/-
3	A	Power Supply	NGSM 32/10	R&S	3939	400000192	ne	-/-	-/-
4	A	Analy zer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	02.02.2018	02.02.2020
5	A	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	16.08.2016	16.08.2017
6	A	AC-Spannungsquelle variabel	MV2616-V	EM-Test	0397-12	300003259	k	11.12.2015	11.12.2017
7	A	Bluetooth Tester	CBT35	R&S	100635	300003907	ne	-/-	-/-

7 Sequence of testing

7.1 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position ± 45° and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

7.2 Sequence of testing radiated spurious 1 GHz to 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premereasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

7.3 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

7.4 Sequence of testing radiated spurious above 18 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

8 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Carrier frequency separation	± 21.5 kHz
Number of hopping channels	-/-
Time of occupancy	According BT Core specification
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

9 Summary of measurement results

<input checked="" type="checkbox"/>	No deviations from the technical specifications were ascertained
<input type="checkbox"/>	There were deviations from the technical specifications ascertained
<input type="checkbox"/>	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS - 247, Issue 2	See table!	2017-04-12	-/-

Test specification clause	Test case	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4) RSS - 247 / 5.4 (b)	Antenna gain	Nominal	Nominal	GFSK			-/-		Declared
§15.247(a)(1) RSS - 247 / 5.1 (b)	Carrier frequency separation	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(a)(1) RSS - 247 / 5.1 (d)	Number of hopping channels	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(a)(1) (iii) RSS - 247 / 5.1 (d)	Time of occupancy (dwell time)	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
§15.247(a)(1) RSS - 247 / 5.1 (a)	Spectrum bandw idth of a FHSS system bandw idth	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.247(b)(1) RSS - 247 / 5.4 (b)	Maximum output power	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.247(d) RSS - 247 / 5.5	Detailed spurious emissions @ the band edge - conducted	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance radiated	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.247(d) RSS - 247 / 5.5	Spurious emissions conducted	Nominal	Nominal	GFSK Pi/4 DQPSK 8 DPSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.209(a) RSS - Gen	Spurious emissions radiated below 30 MHz	Nominal	Nominal	GFSK	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated 30 MHz to 1 GHz	Nominal	Nominal	GFSK RX mode	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated above 1 GHz	Nominal	Nominal	GFSK RX mode	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	
§15.107(a) §15.207	Conducted emissions below 30 MHz (AC conducted)	Nominal	Nominal	GFSK RX mode	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	-/-
					<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

10 Additional comments

The Bluetooth® word mark and logos are owned by the Bluetooth SIG Inc. and any use of such marks by CTC advanced GmbH is under license.

Reference documents:	Customer Questionnaire 3-3-TECH-587 920-04 Flir Lennox antenna characterization A
Special test descriptions:	None
Configuration descriptions:	TX tests: were performed with x-DH5 packets and static PRBS pattern payload. RX/Standby tests: BT test mode enabled, scan enabled, TX Idle
Test mode:	<input checked="" type="checkbox"/> Bluetooth Test mode loop back enabled (EUT is controlled over CBT/CMU) <input type="checkbox"/> Special software is used. EUT is transmitting pseudo random data by itself
Antennas and transmit operating modes:	<input checked="" type="checkbox"/> Operating mode 1 (single antenna) - Equipment with 1 antenna, - Equipment with 2 diversity antennas operating in switched diversity mode by which at any moment in time only 1 antenna is used, - Smart antenna system with 2 or more transmit/receive chains, but operating in a mode where only 1 transmit/receive chain is used)

11 Measurement results

11.1 Antenna gain

Limits:

FCC	IC
6 dBi / > 6 dBi output power and power density reduction required	

Results:

T _{nom}	V _{nom}	DTS band 2400 MHz to 2483.5 MHz
Gain [dBi] Declared by the customer		-1.5

Plots: antenna characterization and gain (provided by the customer)

Plot 1: plane definitions



Figure 3 Measurement plane definitions



Figure 4 XY-plane



Figure 5 XZ-plane



Figure 6 YZ-plane

Plot 2: XY-plane

2.3.2 XY-plane

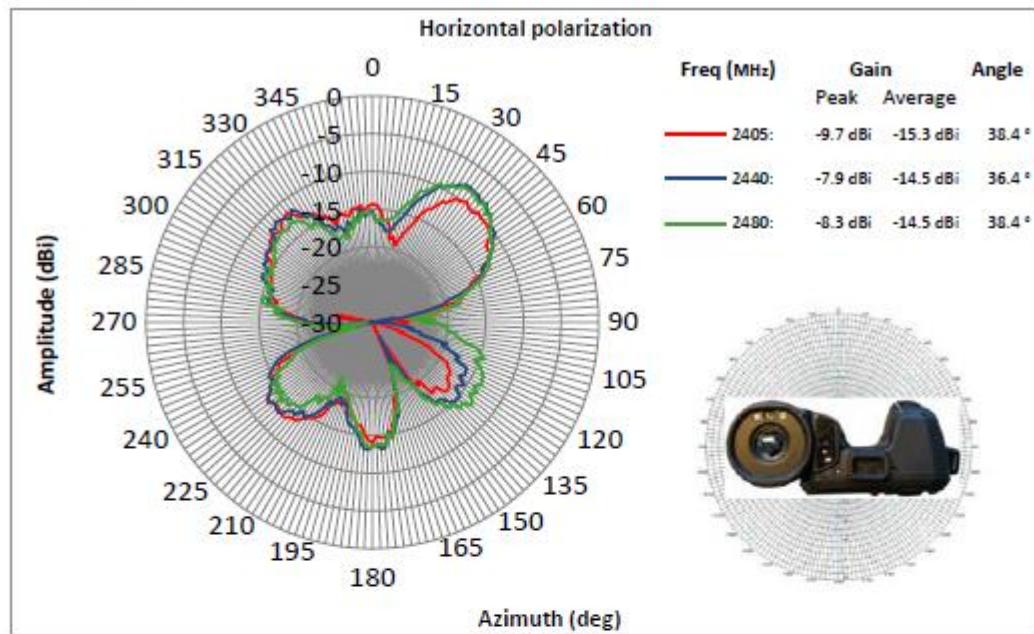


Figure 8 2,5GHz XY-plane, horizontal polarization

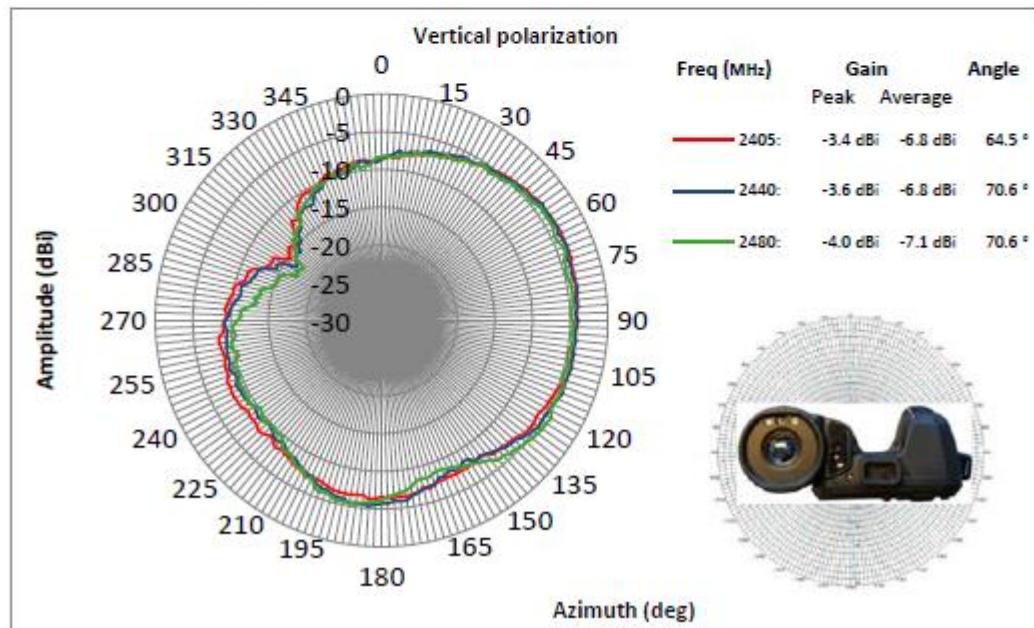


Figure 9 2,5GHz XY-plane, vertical polarization

Plot 3: XZ-plane

2.3.3 XZ-plane

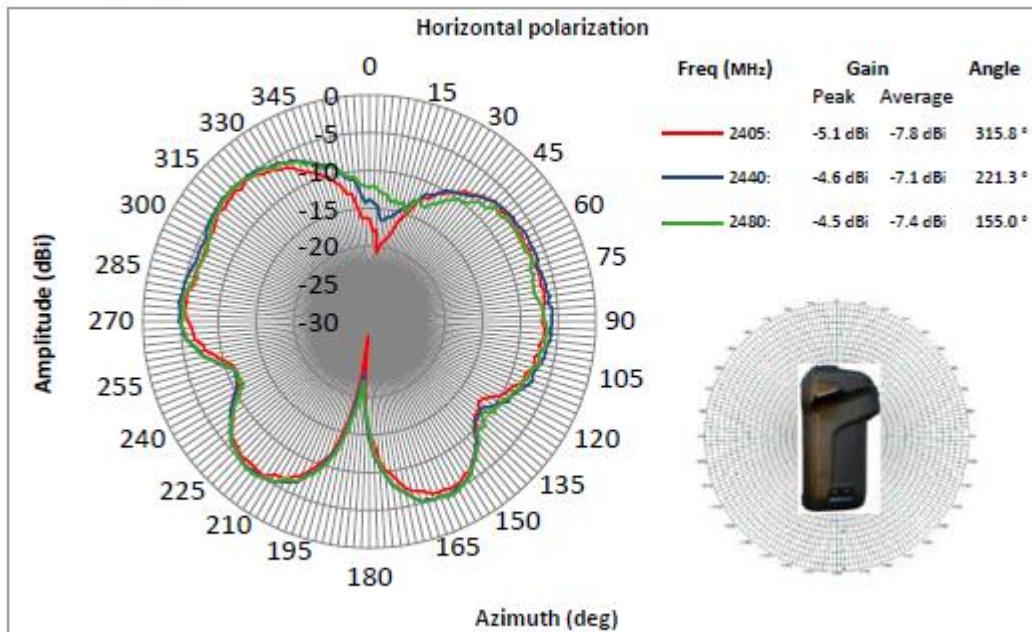


Figure 12 2,5GHz XZ-plane, horizontal polarization

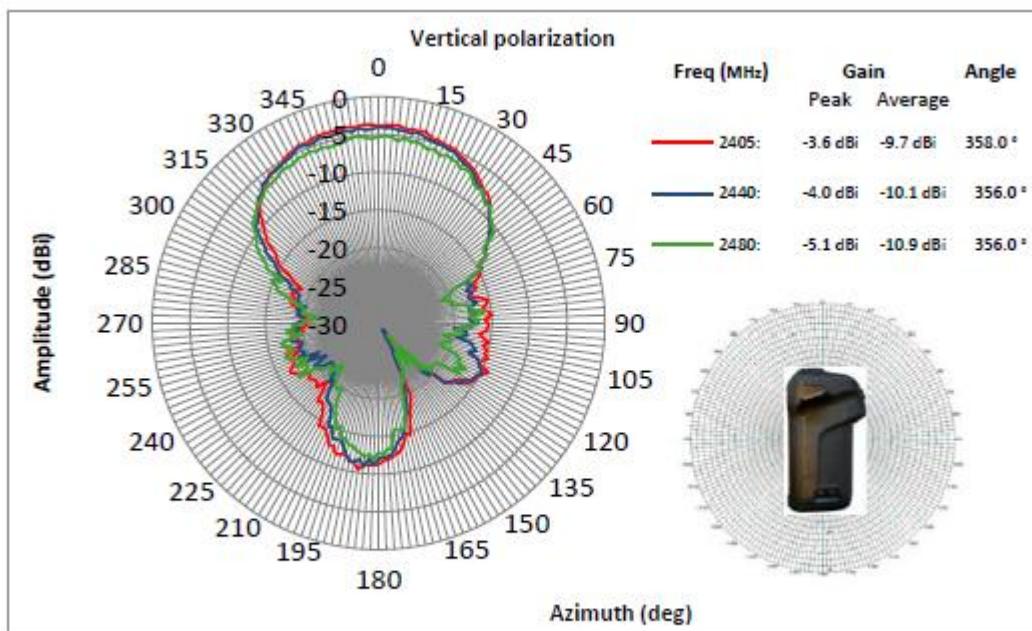


Figure 13 2,5GHz XZ-plane, vertical polarization

Plot 4: YZ-plane

2.3.4 YZ-plane

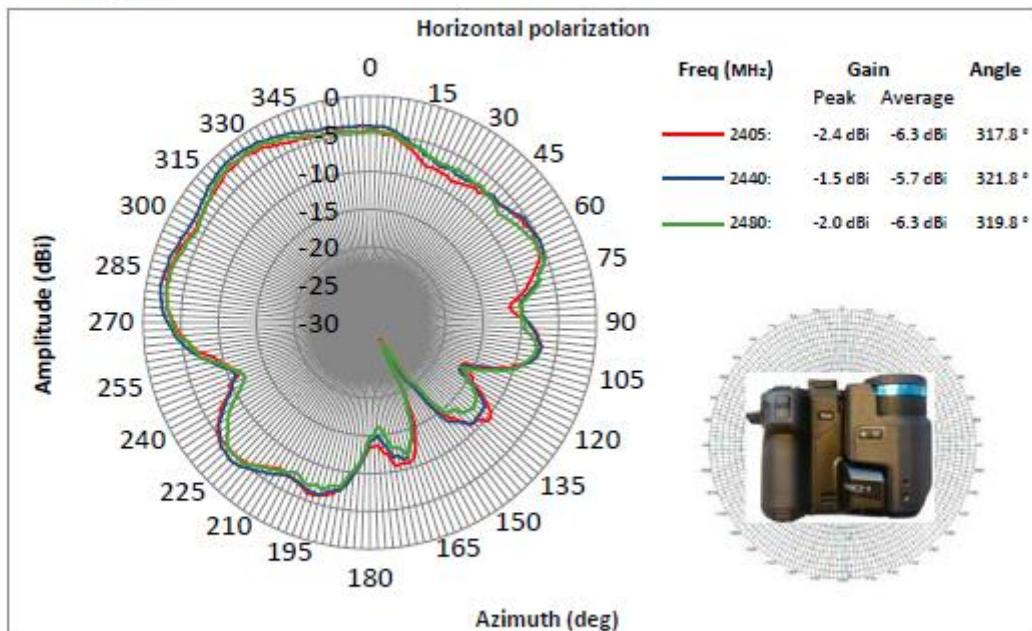


Figure 16 2.5GHz YZ-plane, horizontal polarization

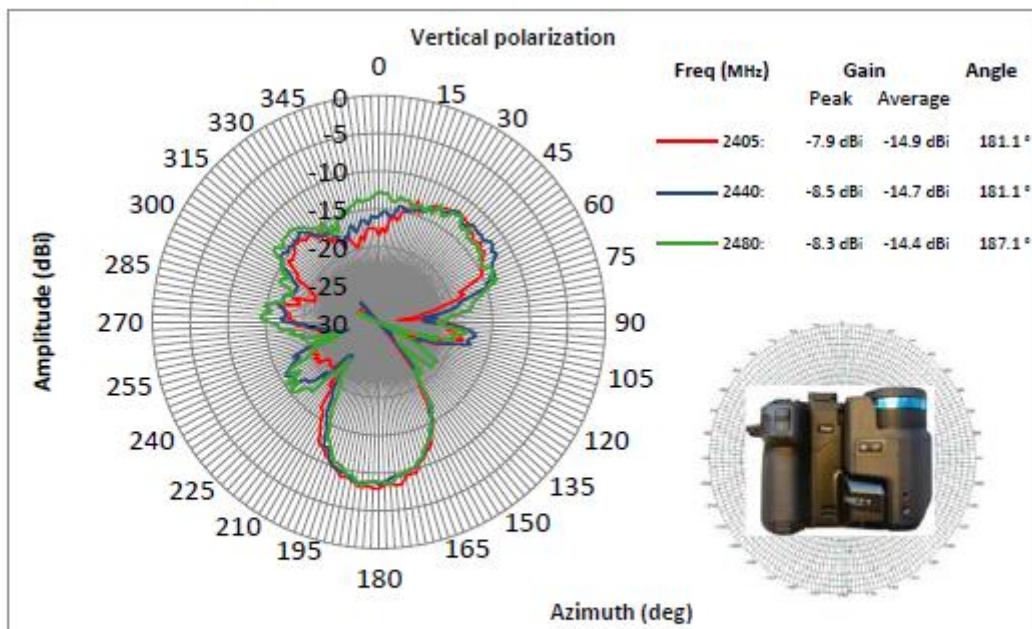


Figure 17 2.5GHz YZ-plane, vertical polarization

Plot 5: summary

3 Summary

The WiFi antenna within the *Flir Lennox* thermal camera has been characterized. The maximum antenna gain has been measured to be -1,5dBi for the 2.4GHz band and 2,0dBi for the 5GHz band.

11.2 Carrier frequency separation

Description:

Measurement of the carrier frequency separation of a hopping system. The carrier frequency separation is constant for all modulation-modes. We use GFSK-modulation to show compliance. EUT in hopping mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	4 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

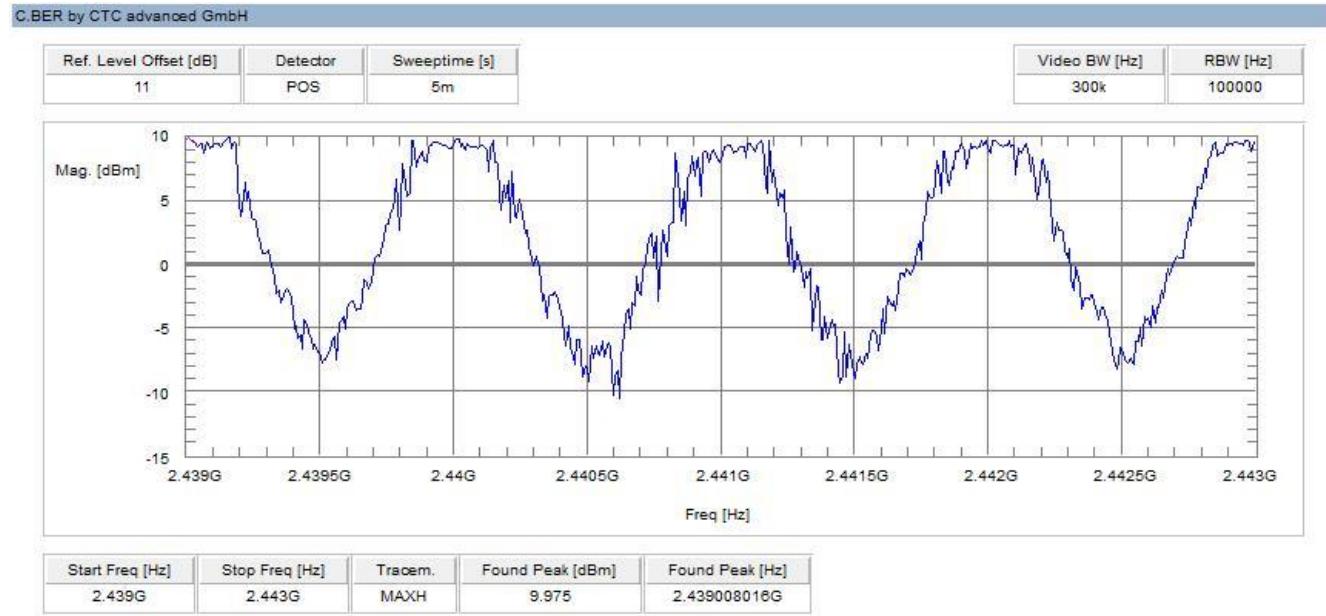
FCC	IC
Carrier frequency separation	
Minimum 25 kHz or two-thirds of the 20 dB bandwidth of the hopping system whichever is greater.	

Result:

Carrier frequency separation	~ 1 MHz
------------------------------	---------

Plot:

Plot 1: Carrier frequency separation (GFSK modulation)



11.3 Number of hopping channels

Description:

Measurement of the total number of used hopping channels. The number of hopping channels is constant for all modulation-modes. We use GFSK-modulation to show compliance. EUT in hopping mode.

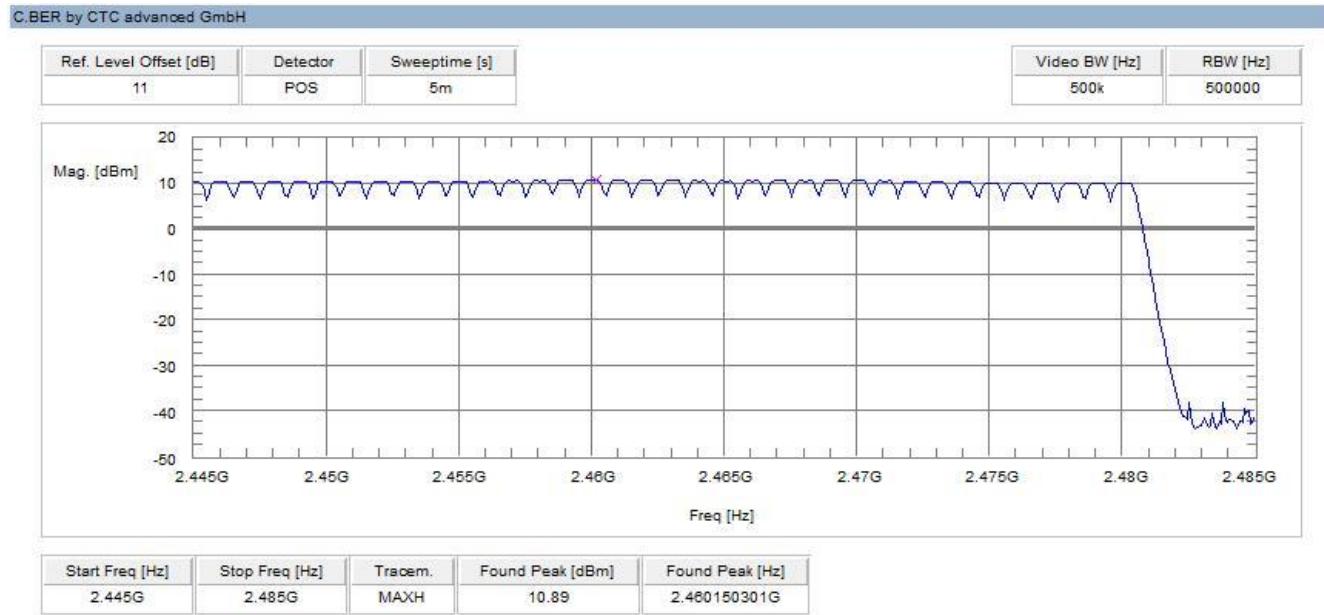
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	500 kHz
Video bandwidth	500 kHz
Span	Plot 1: 2400 – 2445 MHz Plot 2: 2445 – 2485 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Number of hopping channels	
At least 15 non overlapping hopping channels	

Result:

Number of hopping channels	79
----------------------------	----

Plots:**Plot 1:** Number of hopping channels (GFSK modulation)**Plot 2:** Number of hopping channels (GFSK modulation)

11.4 Time of occupancy (dwell time)

Measurement:

For Bluetooth® devices no measurements mandatory depending on the fixed requirements according to the Bluetooth® Core Specifications!

For Bluetooth® devices:

The channel staying time of 0.4 s within a 31.6 second period in data mode is constant for Bluetooth® devices and independent from the packet type (packet length). The calculation for a 31.6 second period is as follows:

$$\text{Channel staying time} = \text{time slot length} * \text{hop rate} / \text{number of hopping channels} * 31.6 \text{ s}$$

Example for a DH1 packet (with a maximum length of one time slot)

$$\text{Channel staying time} = 625 \mu\text{s} * 1600 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s} (\text{in a } 31.6 \text{ s period})$$

For multi-slot packets the hopping is reduced according to the length of the packet.

Example for a DH3 packet (with a maximum length of three time slots)

$$\text{Channel staying time} = 3 * 625 \mu\text{s} * 1600 / 3 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s} (\text{in a } 31.6 \text{ s period})$$

Example for a DH5 packet (with a maximum length of five time slots)

$$\text{Channel staying time} = 5 * 625 \mu\text{s} * 1600 / 5 * 1/\text{s} / 79 * 31.6 \text{ s} = 0.4 \text{ s} (\text{in a } 31.6 \text{ s period})$$

This is according the Bluetooth® Core Specification V2.0 & V2.1 & V3.0 & V4.0 (+ critical errata) for all Bluetooth® devices and all modulations.

The following table shows the relations:

Packet Size	Pulse Width [ms] *	Max. number of transmissions per channel in 31.6 sec
DH1	0.366	640
DH3	1.622	214
DH5	2.870	128

* according Bluetooth® specification

Results:

Packet Size	Pulse Width [ms]*	Max. number of transmissions in 31.6 sec	Dwell time [Pulse width * Number of transmissions]
DH1	0.366	640	234.2 ms
DH3	1.622	214	347.1 ms
DH5	2.870	128	367.4 ms

Limits:

FCC	IC
Time of occupancy (dwell time)	
The frequency hopping operation shall have an average time of occupancy on any frequency not exceeding 0.4 seconds within a duration in seconds equal to the number of hopping frequencies multiplied by 0.4.	

11.5 Spectrum bandwidth of a FHSS system

Description:

Measurement of the 20dB bandwidth and 99% bandwidth of the modulated signal. The measurement is performed according to the "Measurement Guidelines" (DA 00-705, March 30, 2000). EUT in single channel mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	30 kHz
Video bandwidth	100 kHz
Span	3 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

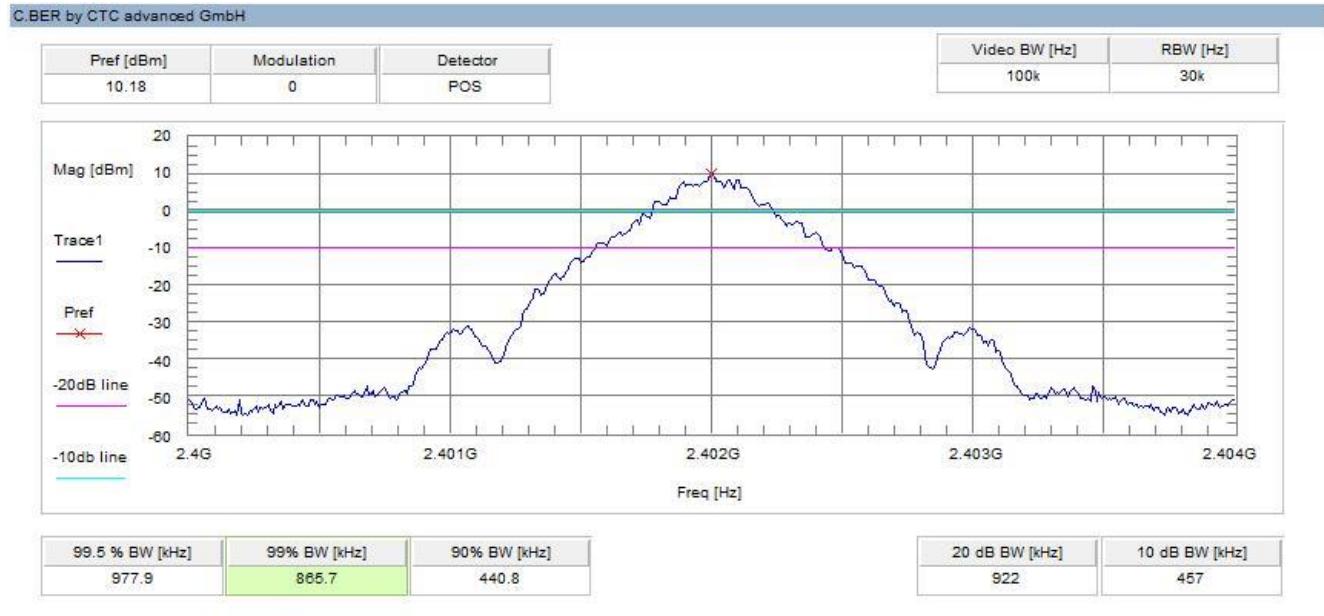
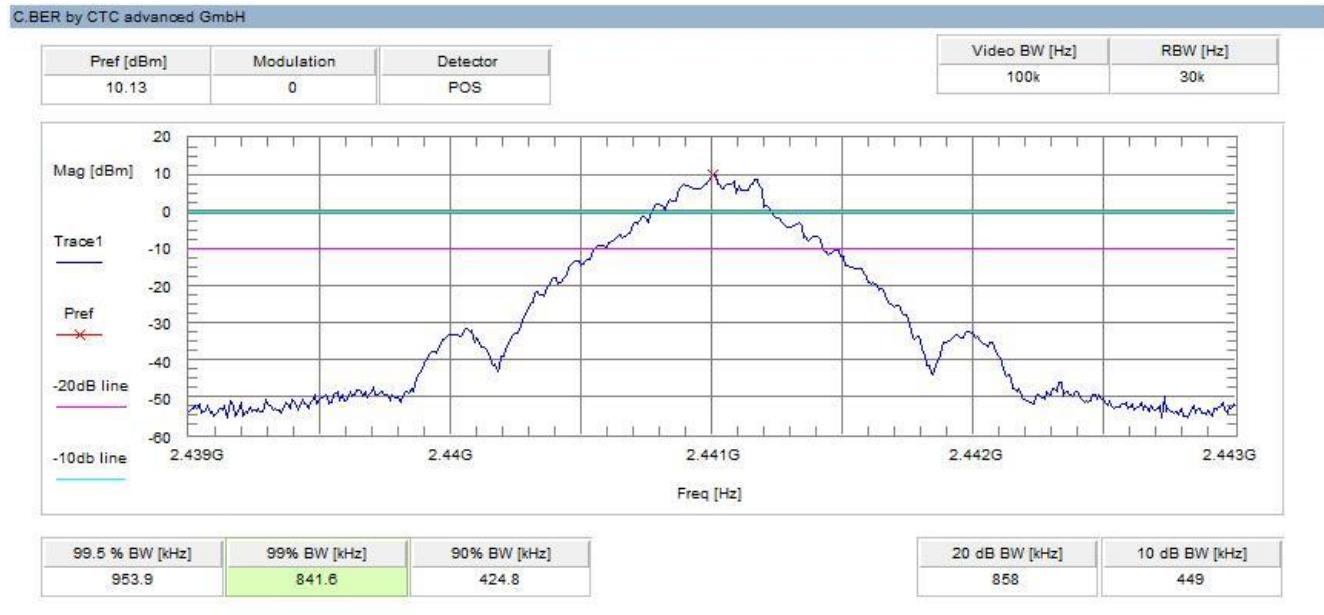
FCC	IC
Spectrum bandwidth of a FHSS system	
GFSK < 1500 kHz Pi/4 DQPSK < 1500 kHz 8DPSK < 1500 kHz	

Results:

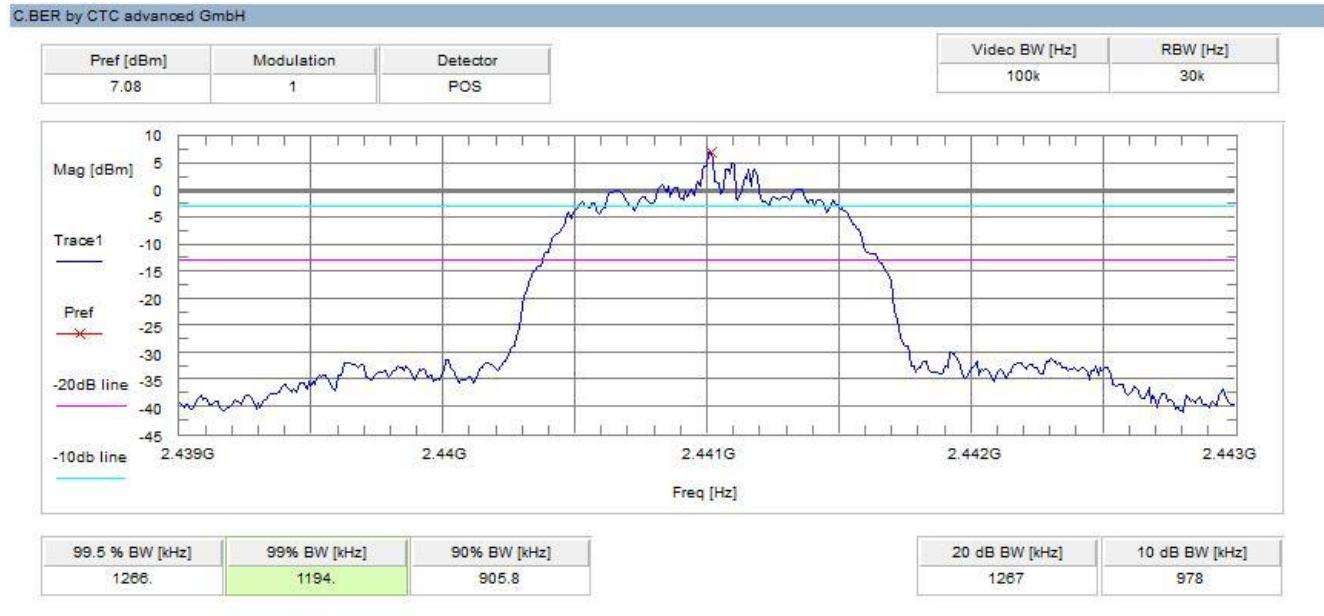
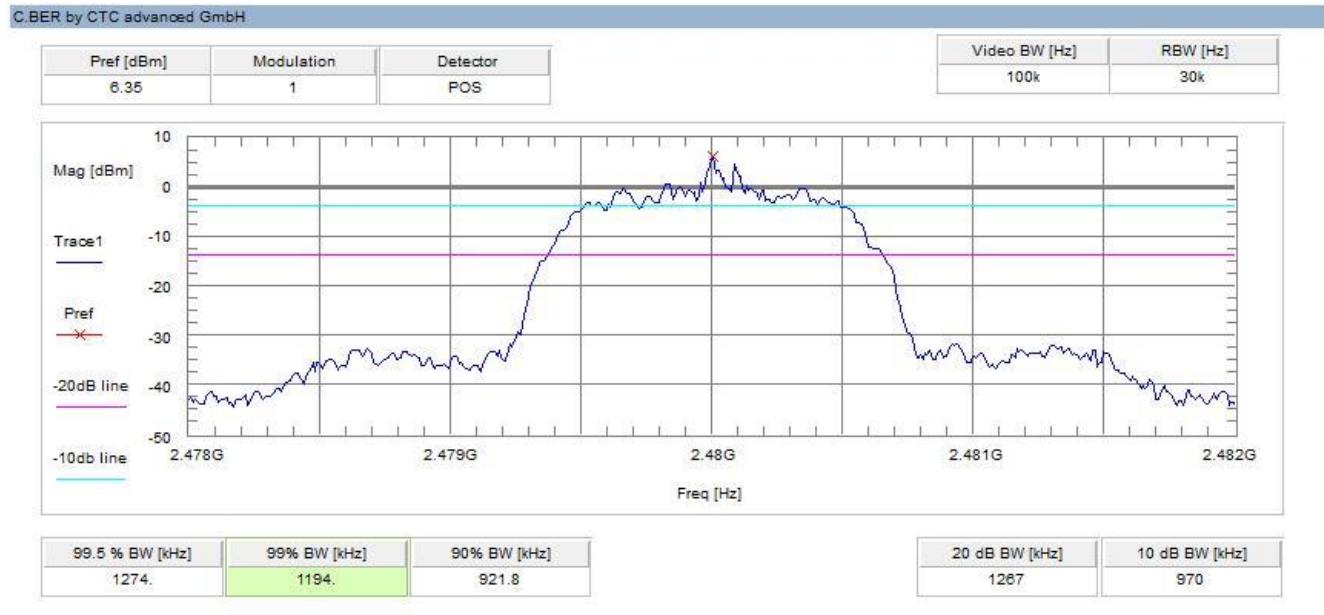
Modulation	20 dB bandwidth [kHz]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	922	858	938
Pi/4 DQPSK	1283	1267	1267
8DPSK	1299	1299	1291

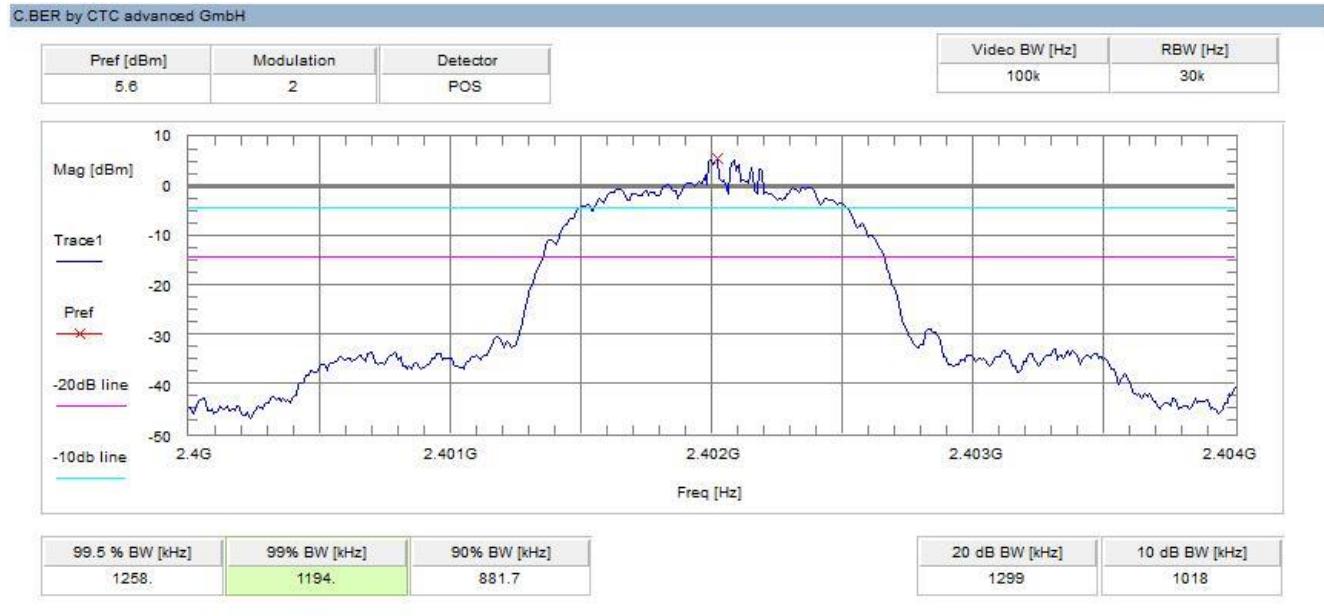
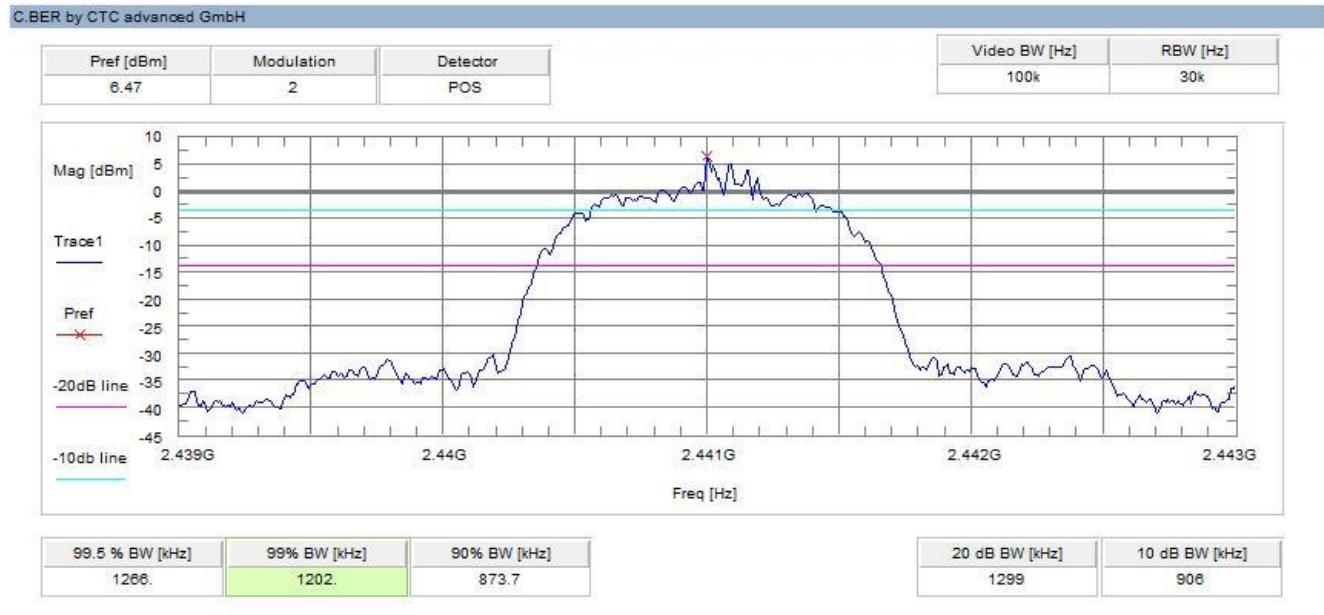
Results:

Modulation	99 % bandwidth [kHz]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	866	842	850
Pi/4 DQPSK	1186	1194	1194
8DPSK	1194	1202	1210

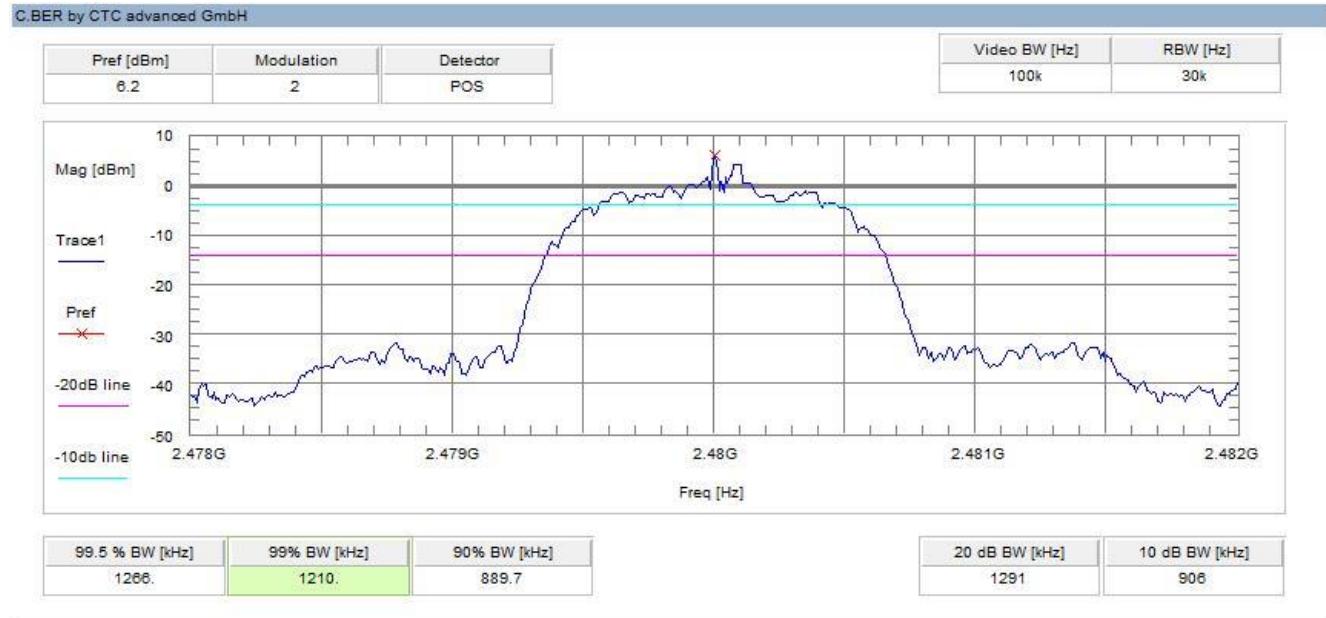
Plots:**Plot 1: lowest channel – 2402 MHz, GFSK modulation****Plot 2: middle channel – 2441 MHz, GFSK modulation**

Plot 3: highest channel – 2480 MHz, GFSK modulation**Plot 4: lowest channel – 2402 MHz, Pi / DQPSK modulation**

Plot 5: middle channel – 2441 MHz, Pi / DQPSK modulation**Plot 6: highest channel – 2480 MHz, Pi / DQPSK modulation**

Plot 7: lowest channel – 2402 MHz, 8 DPSK modulation**Plot 8:** middle channel – 2441 MHz, 8 DPSK modulation

Plot 9: highest channel – 2480 MHz, 8 DPSK modulation



11.6 Maximum output power

Description:

Measurement of the maximum output power conducted and radiated. EUT in single channel mode. The measurement is performed according to the ANSI C63.10.

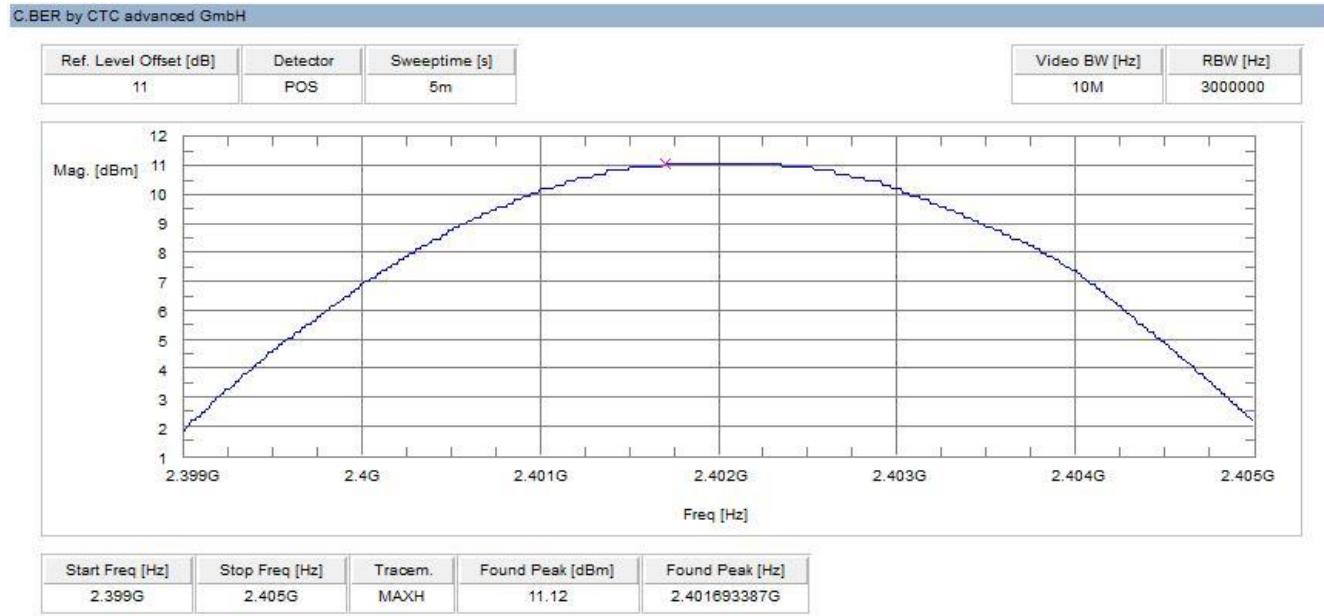
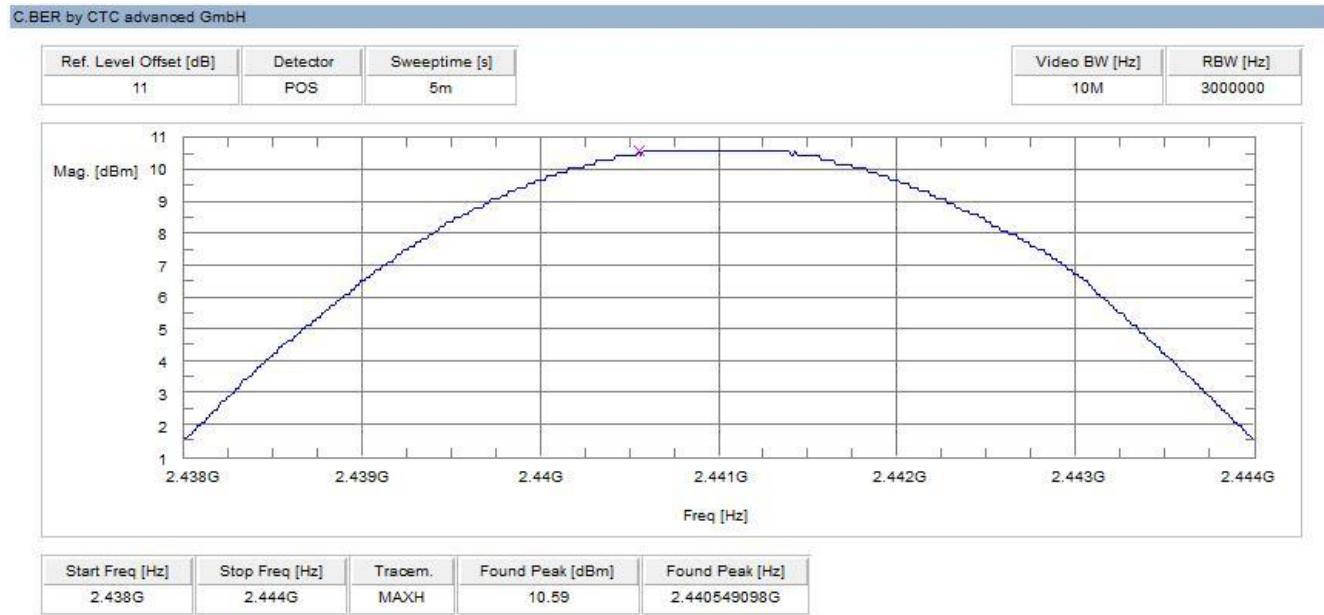
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	10 MHz
Span	6 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

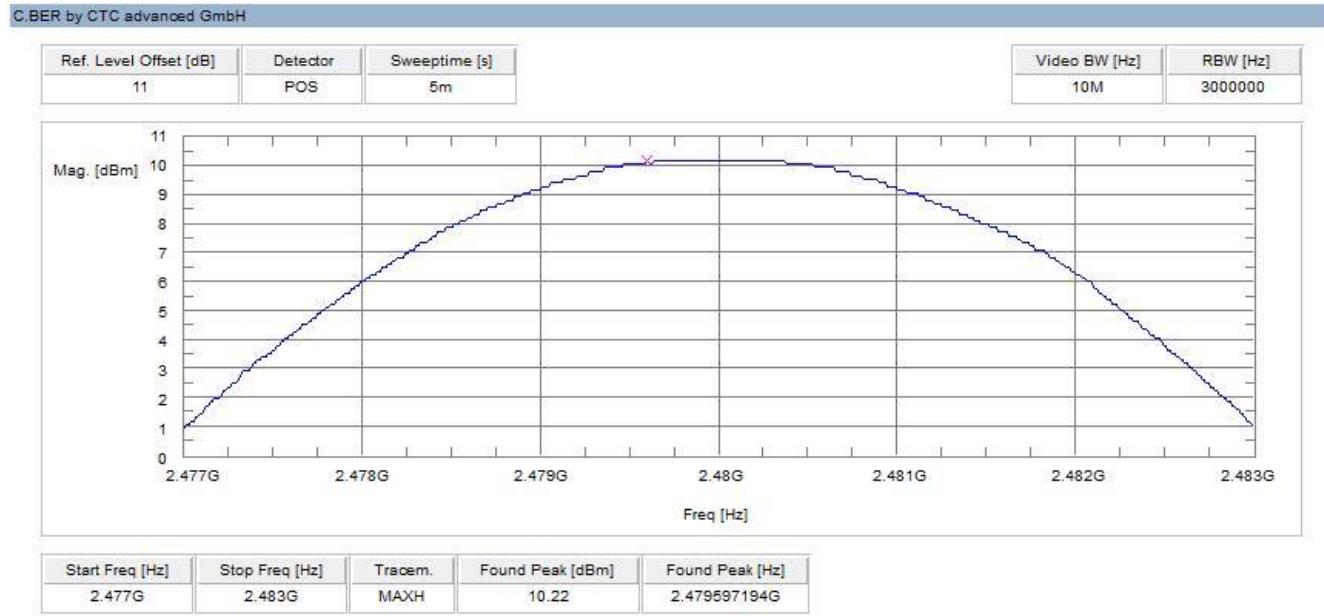
Limits:

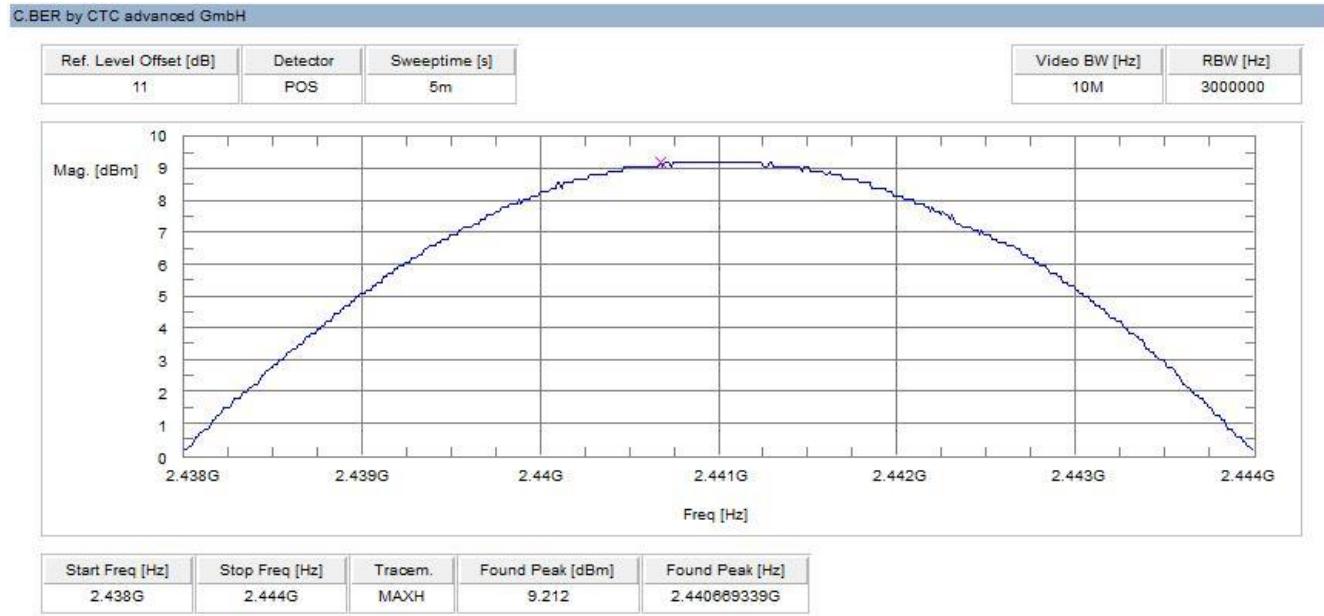
FCC	IC
Maximum output power	
[Conducted: 0.125 W – antenna gain max. 6 dBi] Systems using more than 75 hopping channels: Conducted: 1.0 W – antenna gain max. 6 dBi	

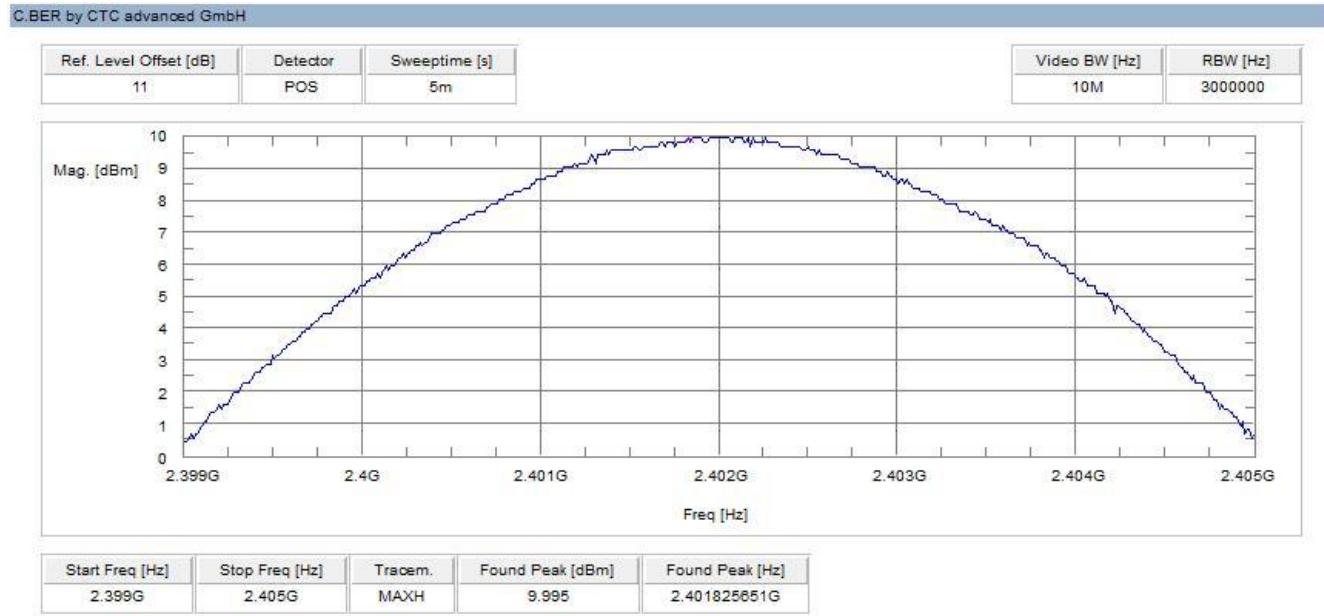
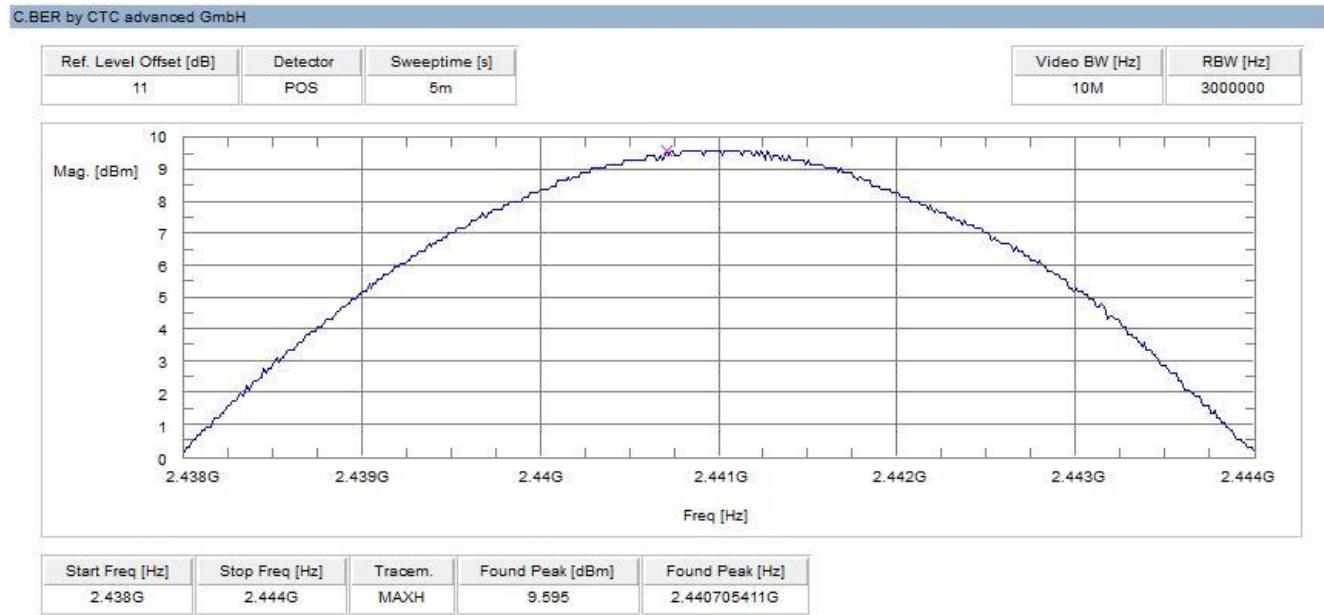
Results:

Modulation	Maximum output power conducted [dBm]		
	2402 MHz	2441 MHz	2480 MHz
GFSK	11.1	10.6	10.2
Pi/4 DQPSK	9.5	9.2	8.7
8 DPSK	10.0	9.6	9.1

Plots:**Plot 1: lowest channel – 2402 MHz, GFSK modulation****Plot 2: middle channel – 2441 MHz, GFSK modulation**

Plot 3: highest channel – 2480 MHz, GFSK modulation**Plot 4:** lowest channel – 2402 MHz, Pi / DQPSK modulation

Plot 5: middle channel – 2441 MHz, Pi / DQPSK modulation**Plot 6:** highest channel – 2480 MHz, Pi / DQPSK modulation

Plot 7: lowest channel – 2402 MHz, 8 DPSK modulation**Plot 8: middle channel – 2441 MHz, 8 DPSK modulation**

Plot 9: highest channel – 2480 MHz, 8 DPSK modulation

11.7 Detailed spurious emissions @ the band edge - conducted

Description:

Measurement of the conducted band edge compliance. EUT is measured at the lower and upper band edge in single channel and hopping mode. The measurement is repeated for all modulations.

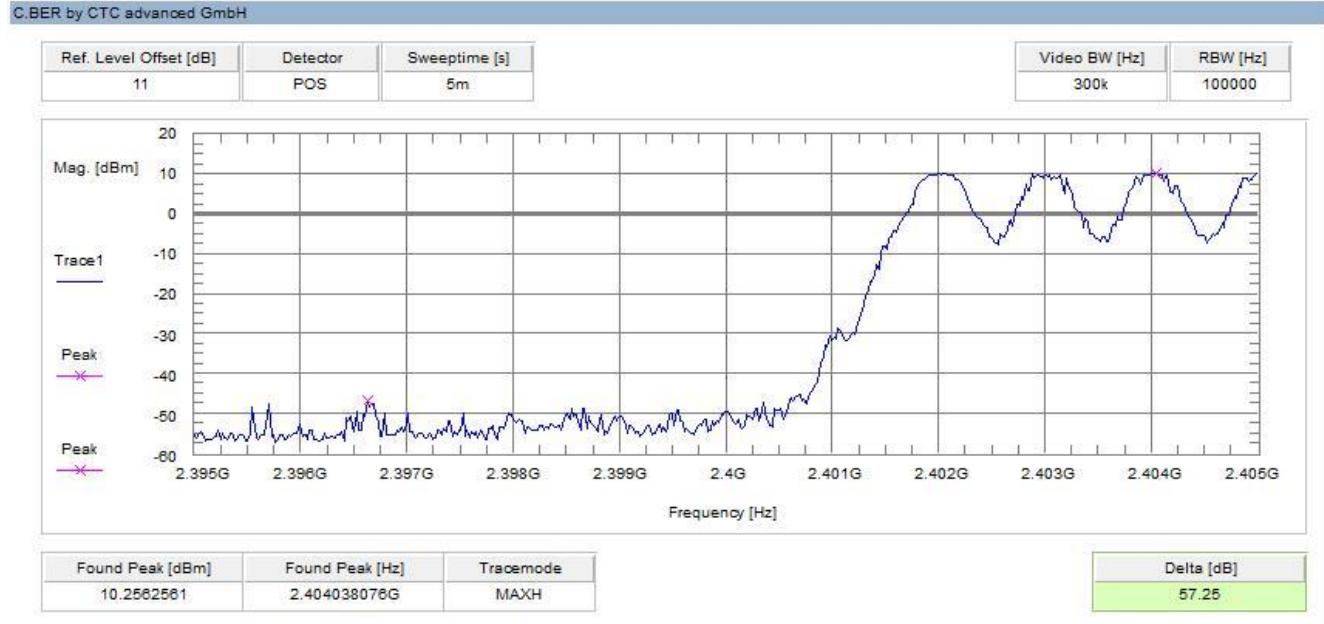
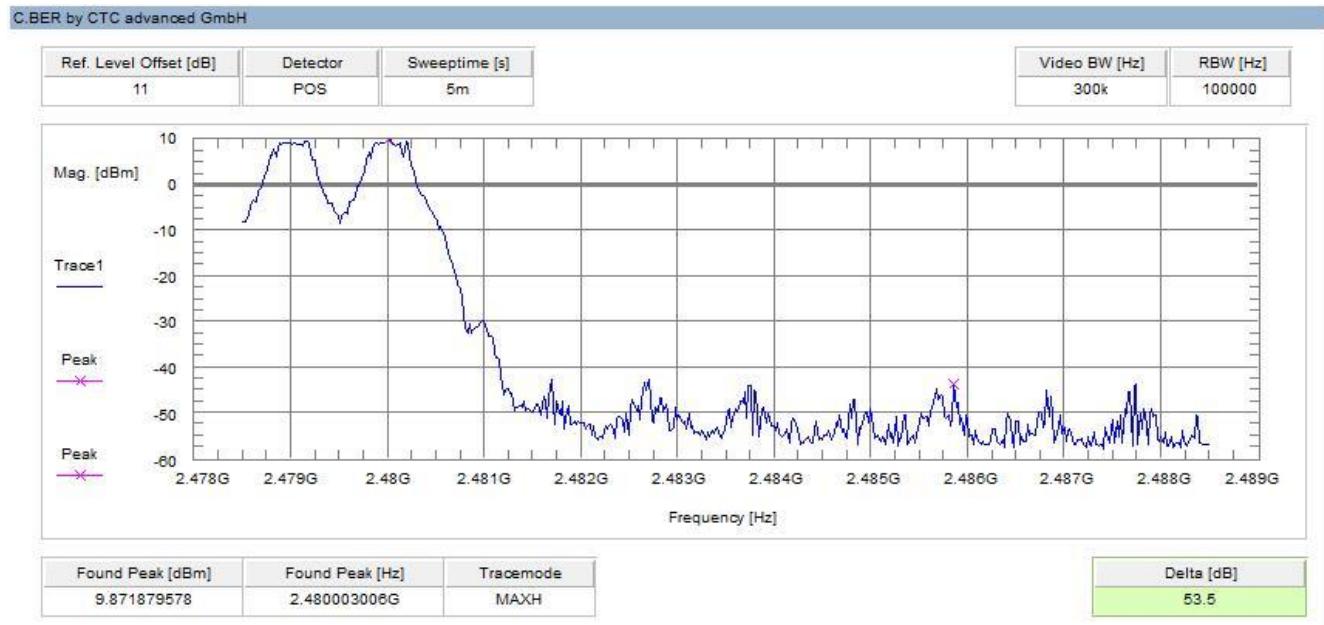
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz / 500 kHz
Span	Lower Band Edge: 2395 – 2405 MHz Upper Band Edge: 2478 – 2489 MHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

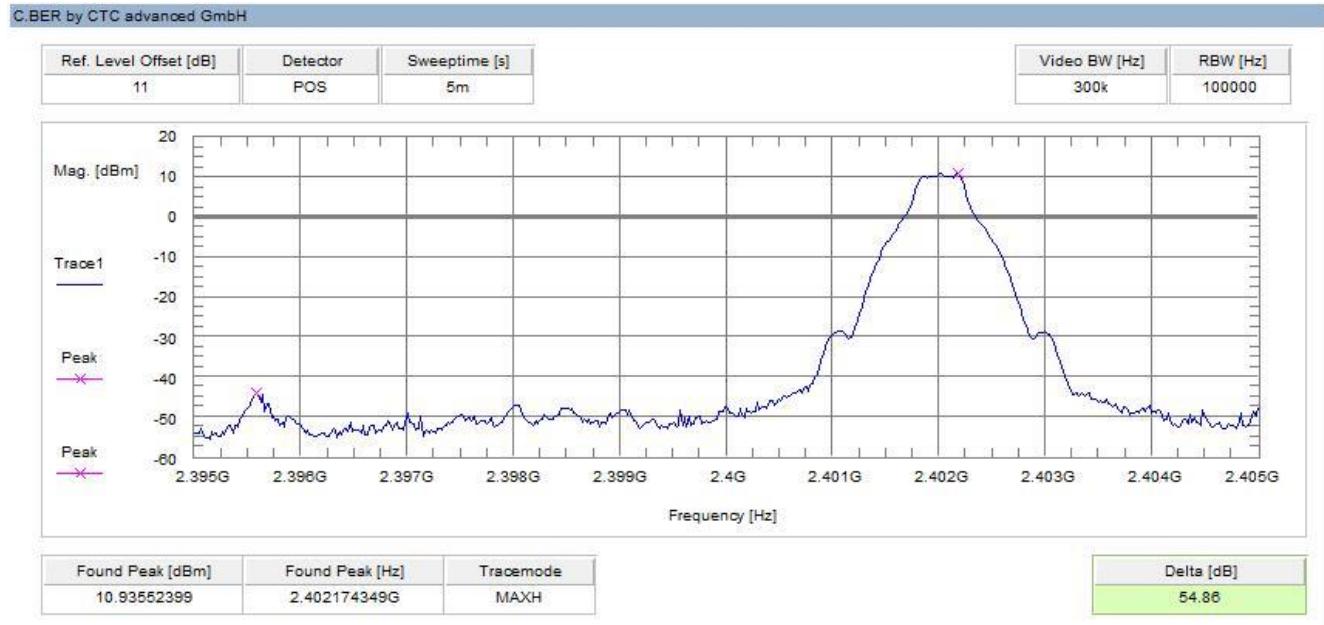
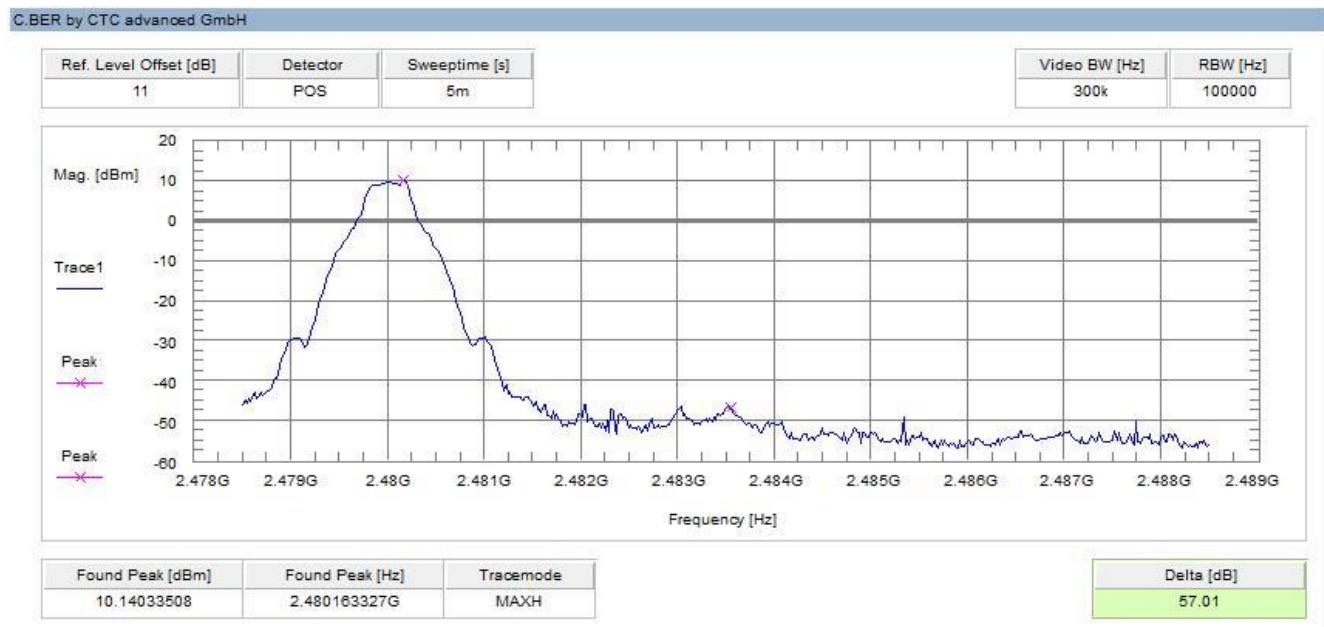
Limits:

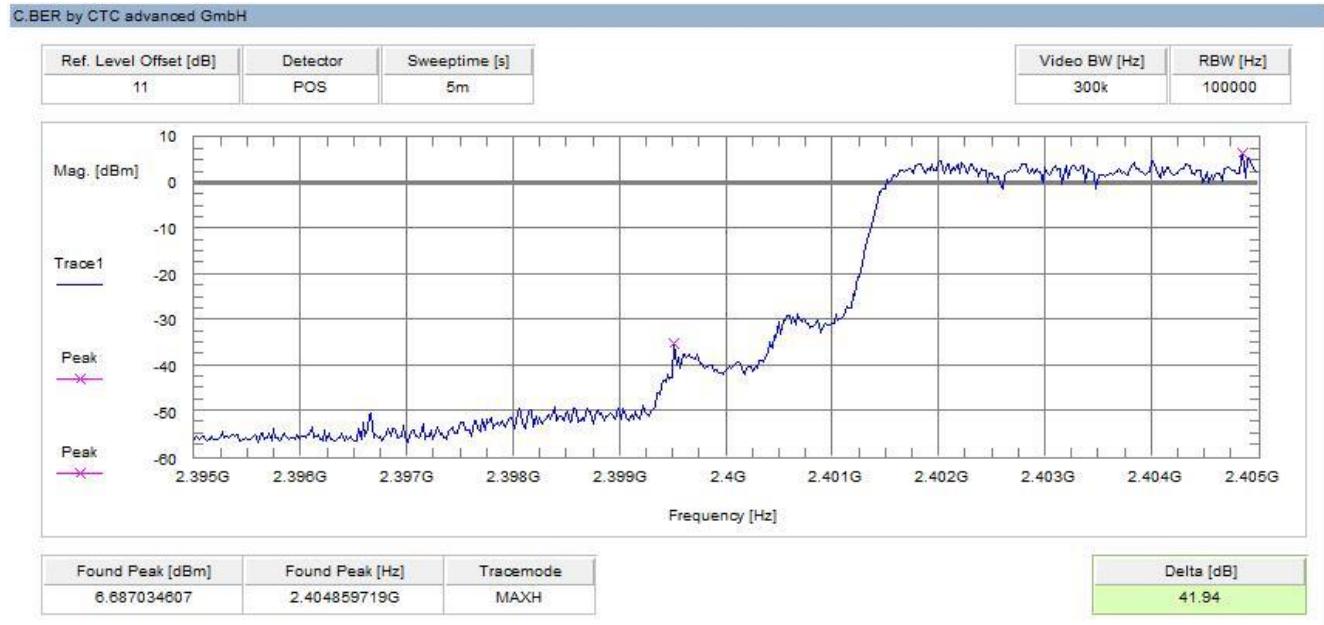
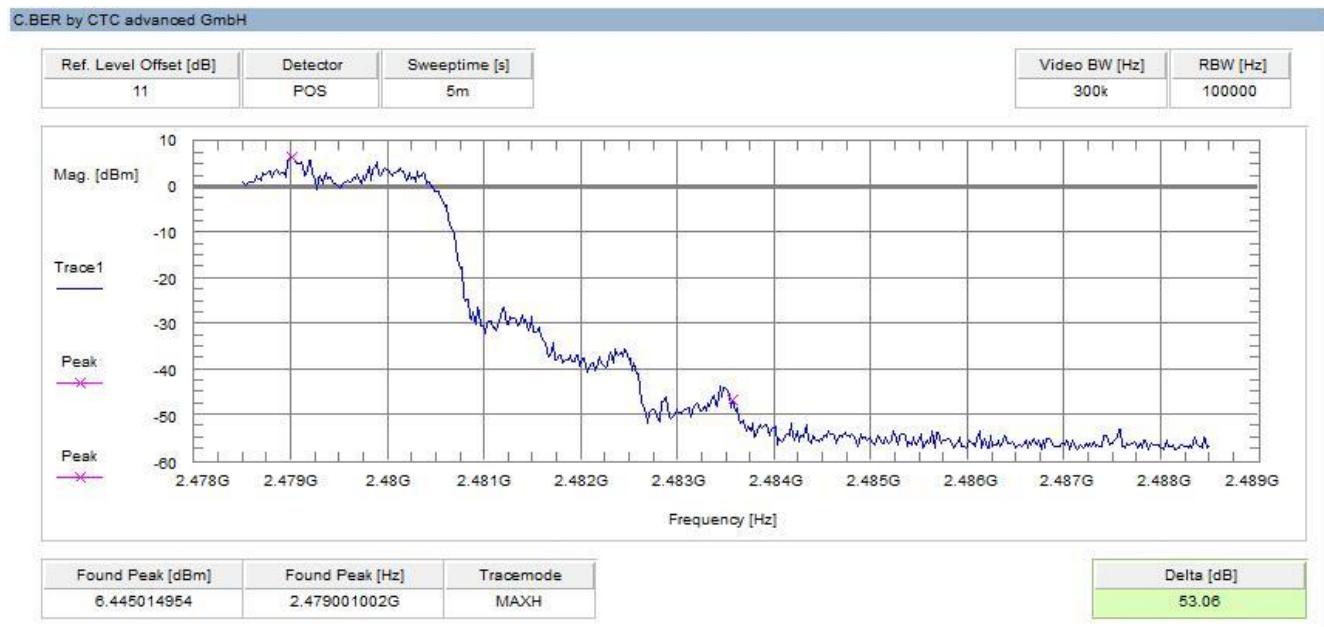
FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.	

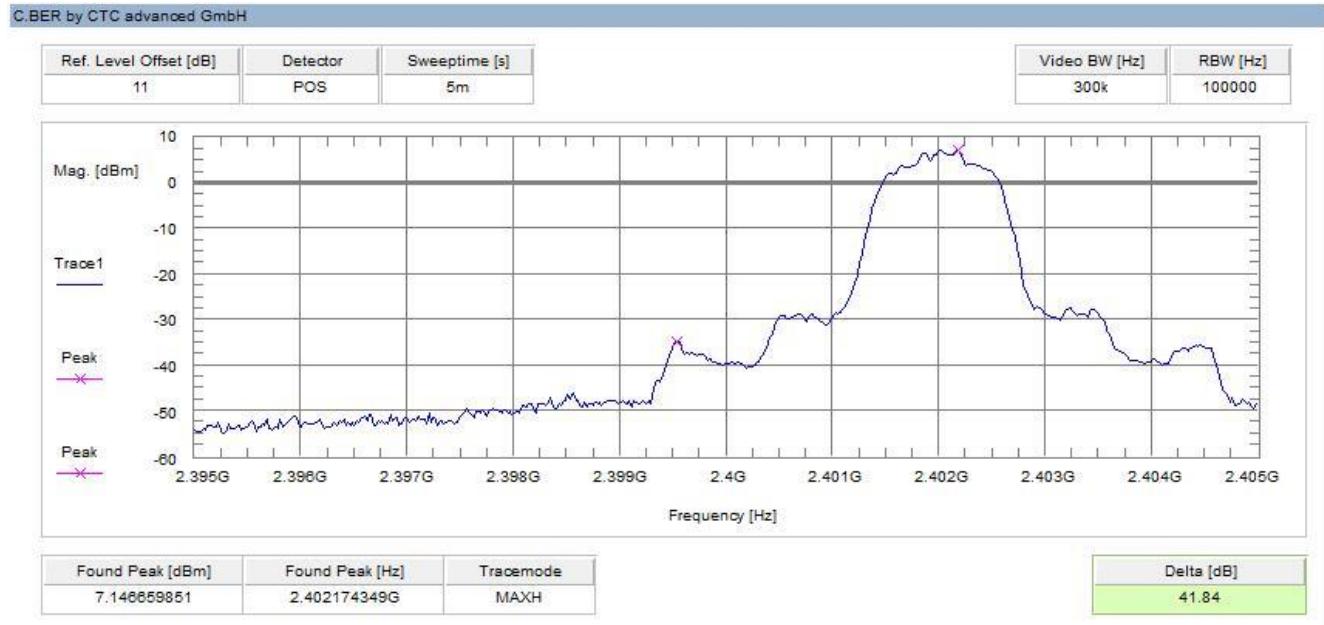
Results:

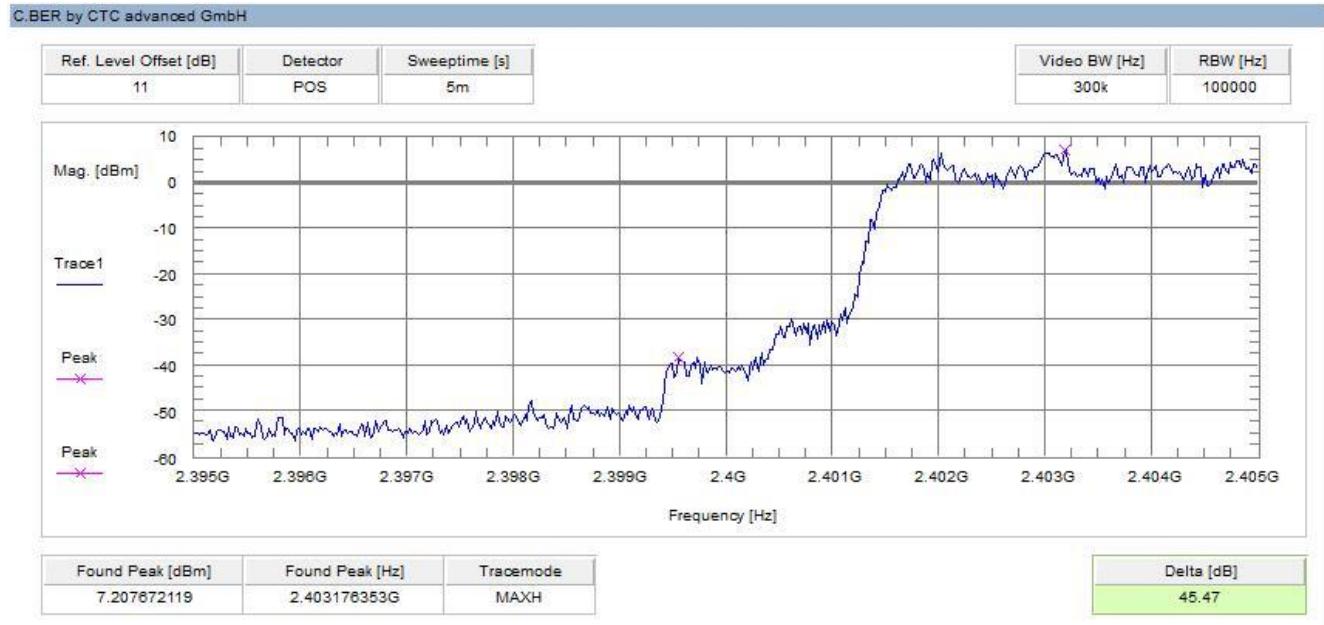
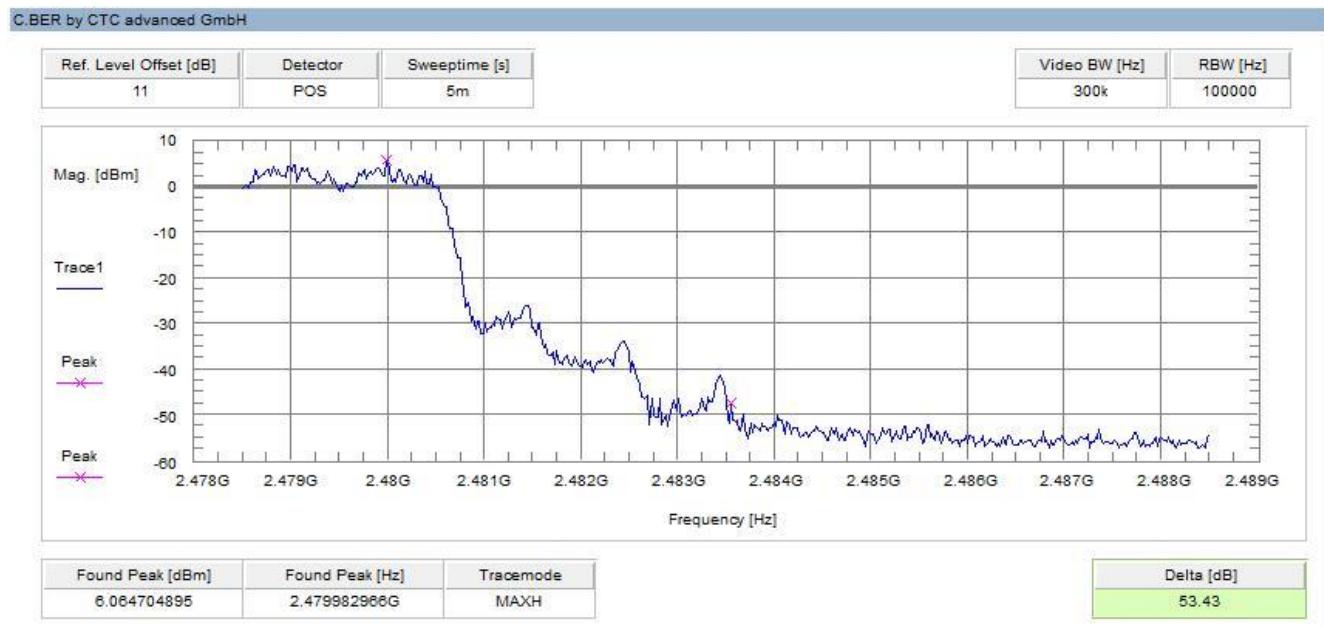
Scenario	Spurious band edge conducted [dB]		
	GFSK	Pi/4 DQPSK	8DPSK
Lower band edge – hopping off	> 20 dB	> 20 dB	> 20 dB
Lower band edge – hopping on	> 20 dB	> 20 dB	> 20 dB
Upper band edge – hopping off	> 20 dB	> 20 dB	> 20 dB
Upper band edge – hopping on	> 20 dB	> 20 dB	> 20 dB

Plots:**Plot 1: Lower band edge – hopping on, GFSK modulation****Plot 2: Upper band edge – hopping on, GFSK modulation**

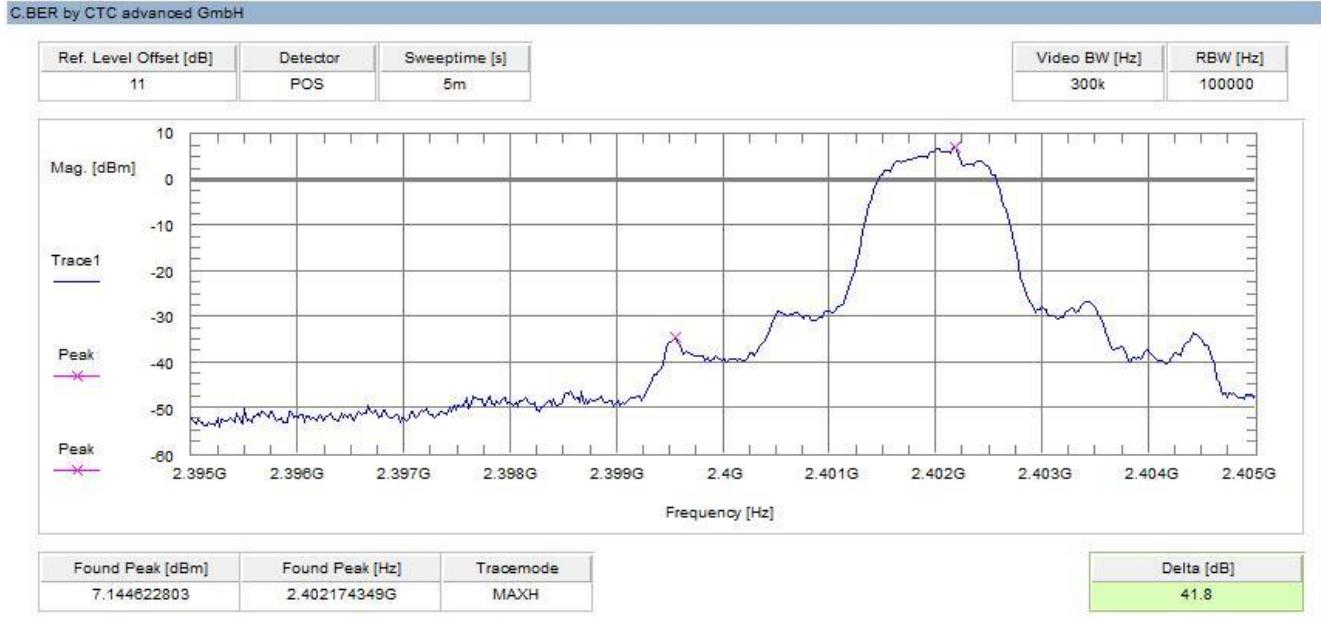
Plot 3: Lower band edge – hopping off, GFSK modulation**Plot 4: Upper band edge – hopping off, GFSK modulation**

Plot 5: Lower band edge – hopping on, Pi/4 DQPSK modulation**Plot 6:** Upper band edge – hopping on, Pi/4 DQPSK modulation

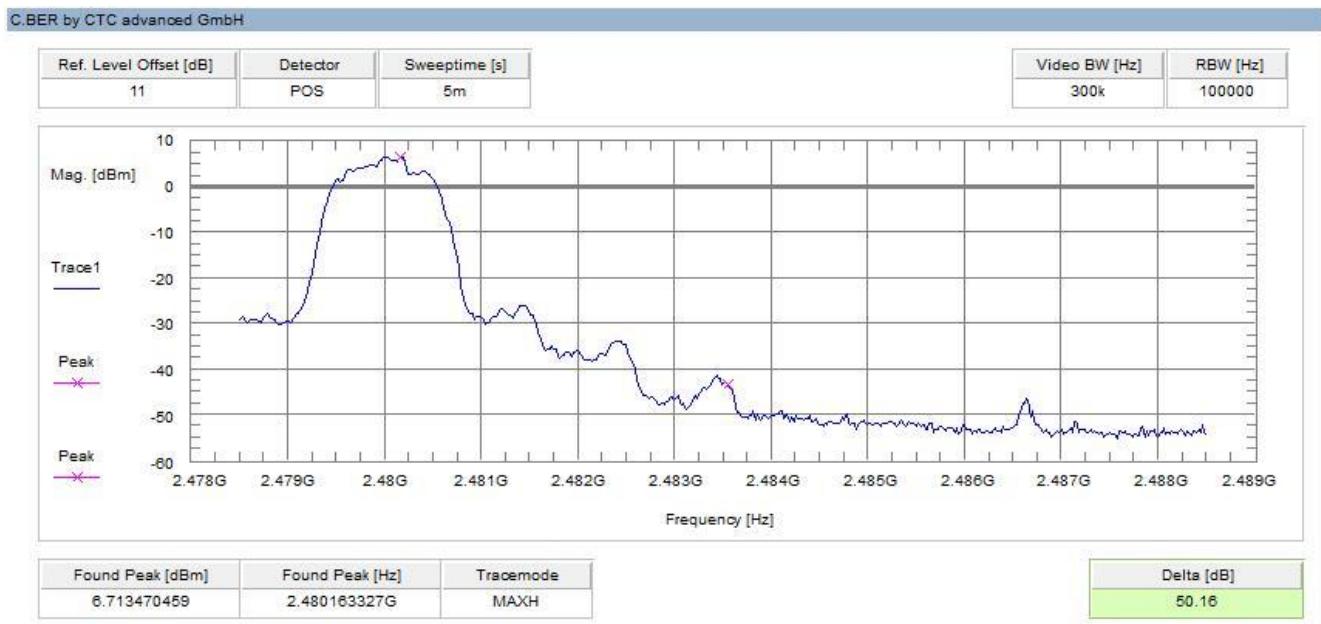
Plot 7: Lower band edge – hopping off, Pi/4 DQPSK modulation**Plot 8: Upper band edge – hopping off, Pi/4 DQPSK modulation**

Plot 9: Lower band edge – hopping on, 8DPSK modulation**Plot 10:** Upper band edge – hopping on, 8DPSK modulation

Plot 11: Lower band edge – hopping off, 8DPSK modulation



Plot 12: Upper band edge – hopping off, 8DPSK modulation



11.8 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to single channel mode and the transmit channel is channel 00 for the lower restricted band and channel 78 for the upper restricted band. The measurement is repeated for all modulations. Measurement distance is 3m.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 MHz
Span	Lower Band: 2370 – 2400 MHz Upper Band: 2480 – 2500 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 B
Measurement uncertainty	See sub clause 8

Limits:

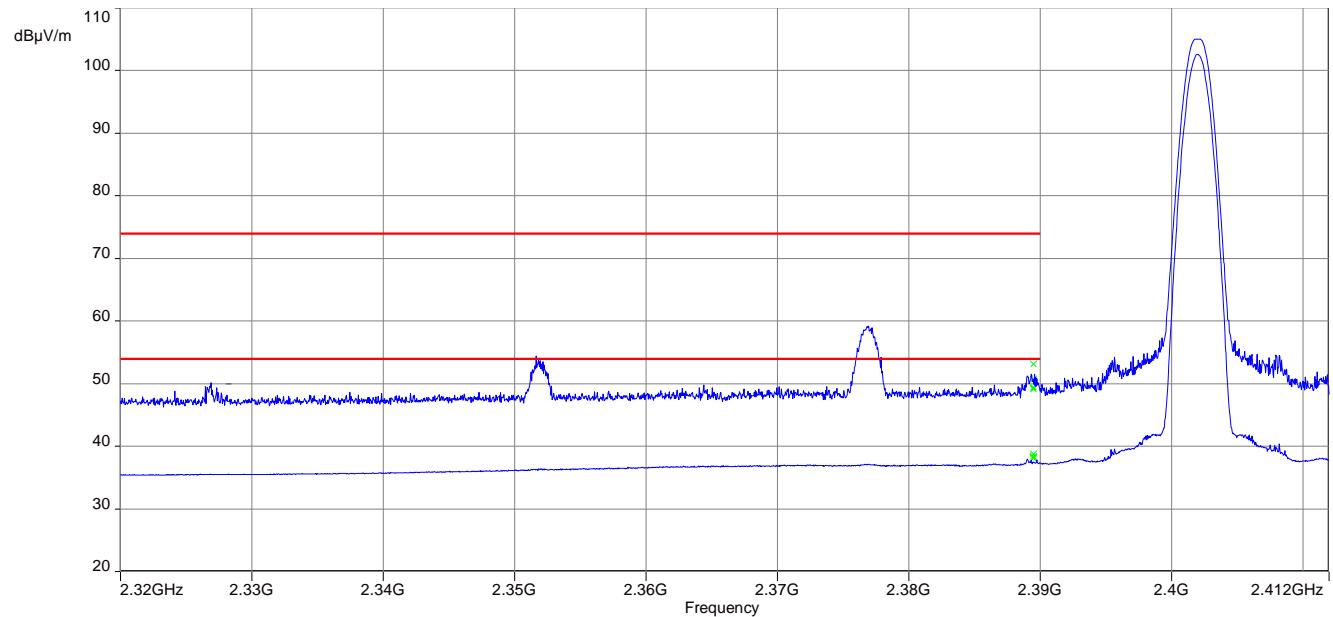
FCC	IC
Band edge compliance radiated	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).	
54 dB μ V/m AVG 74 dB μ V/m Peak	

Results:

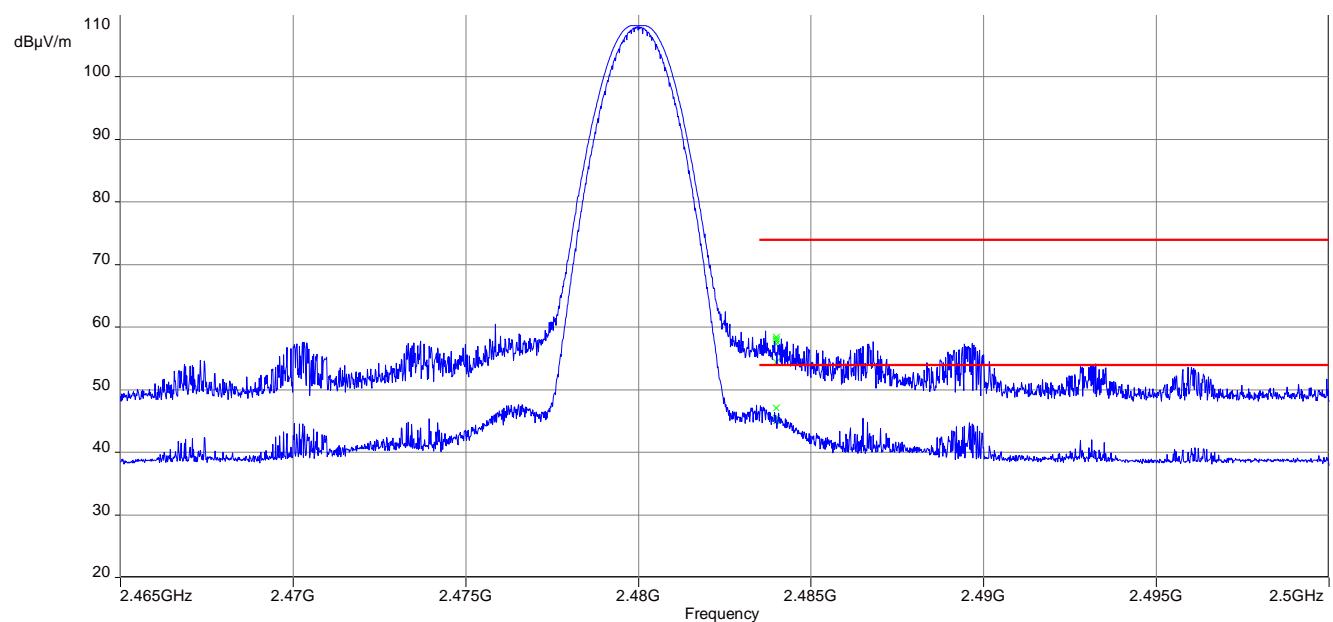
Scenario	Band edge compliance radiated [dB μ V/m]		
	GFSK	Pi/4 DQPSK	8DPSK
Lower restricted band	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP
Upper restricted band	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP	< 54 AVG / < 74 PP

Plots:

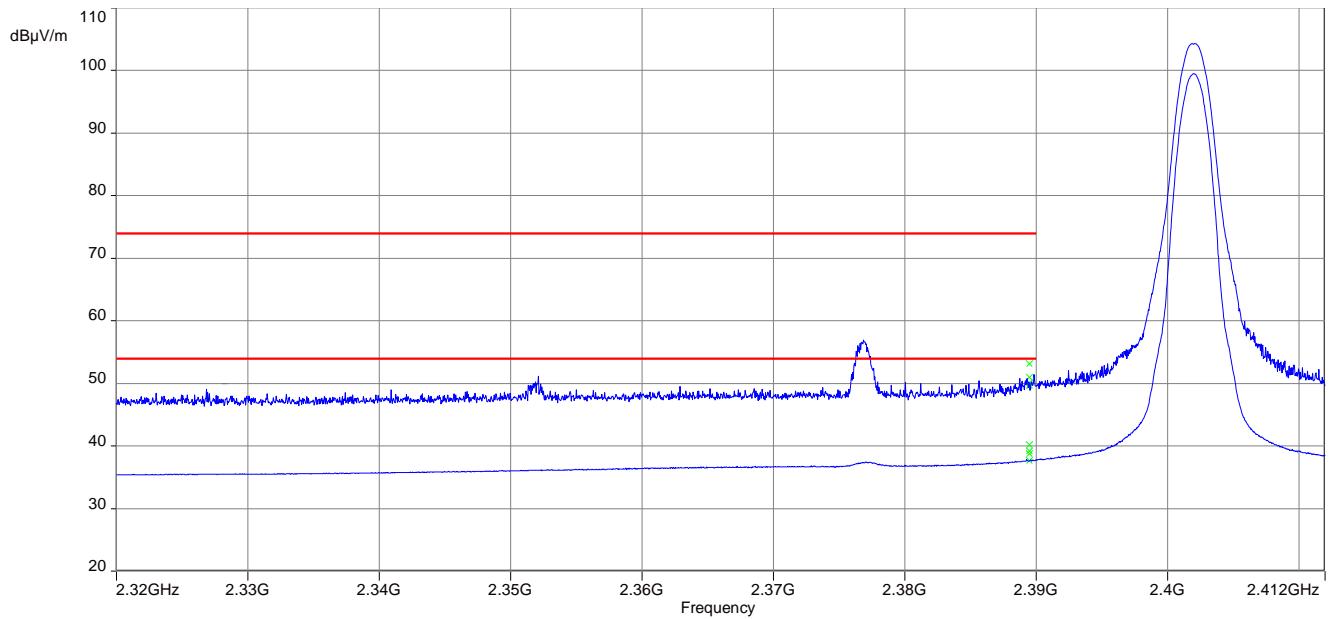
Plot 1: Lower band edge, GFSK modulation, vertical & horizontal polarization



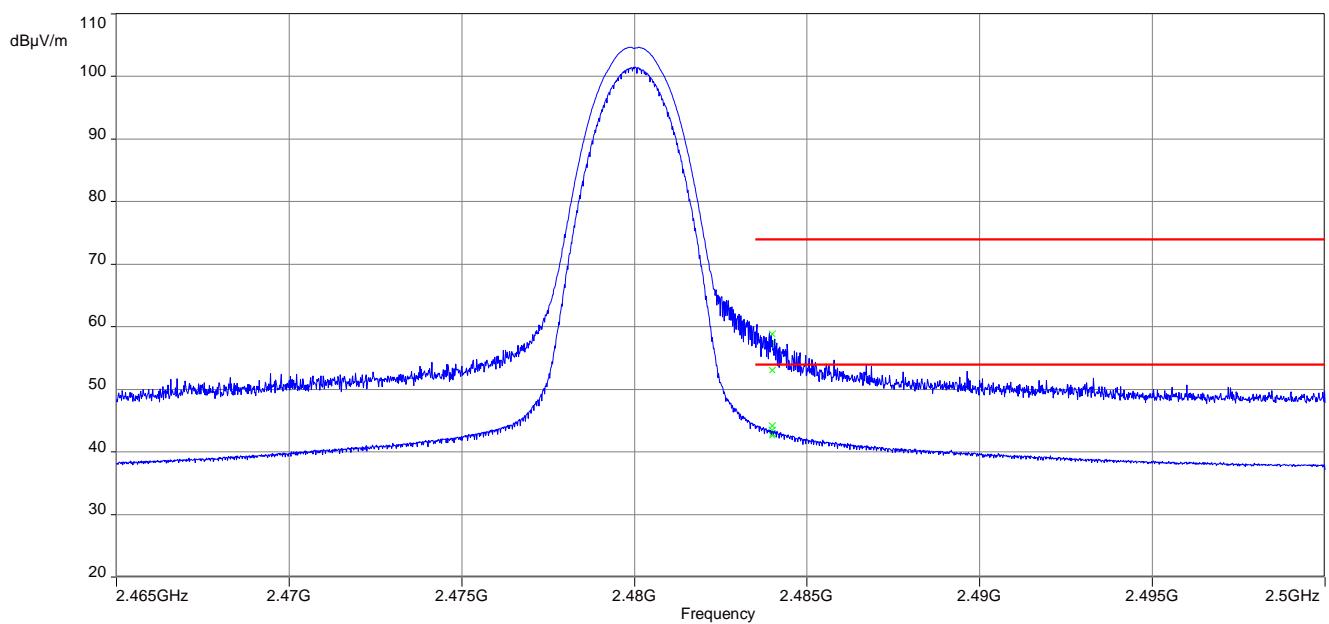
Plot 2: Upper band edge, GFSK modulation, vertical & horizontal polarization



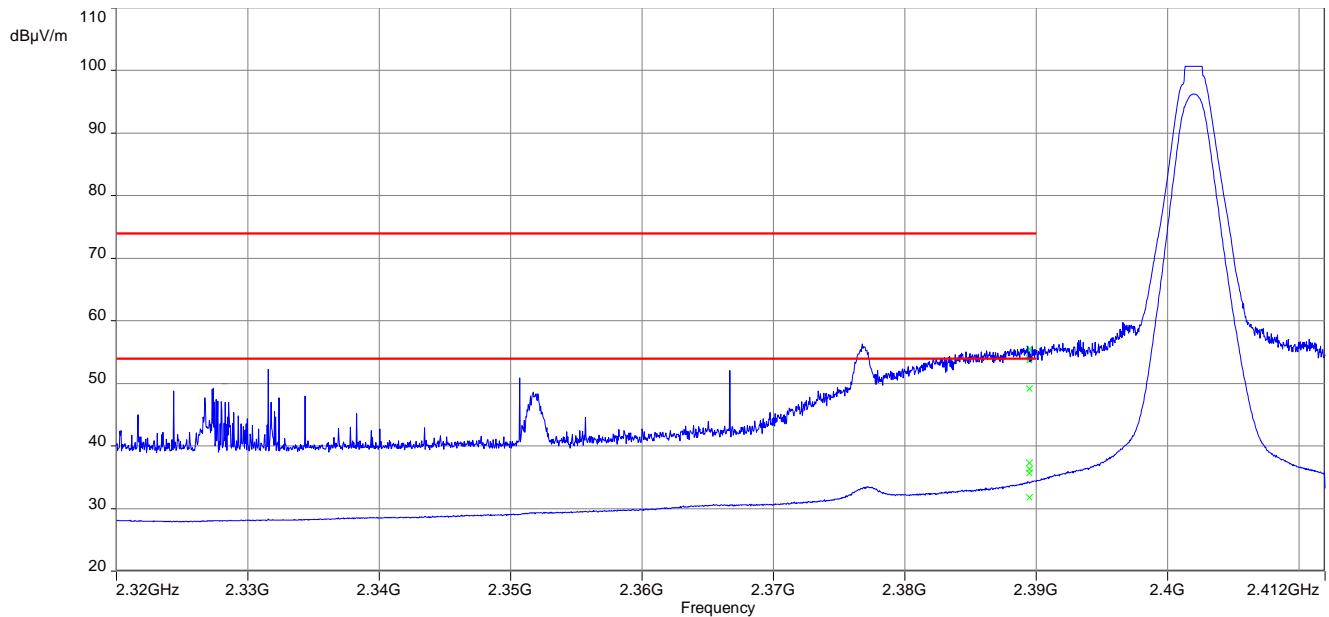
Plot 3: Lower band edge, Pi/4 DQPSK modulation, vertical & horizontal polarization



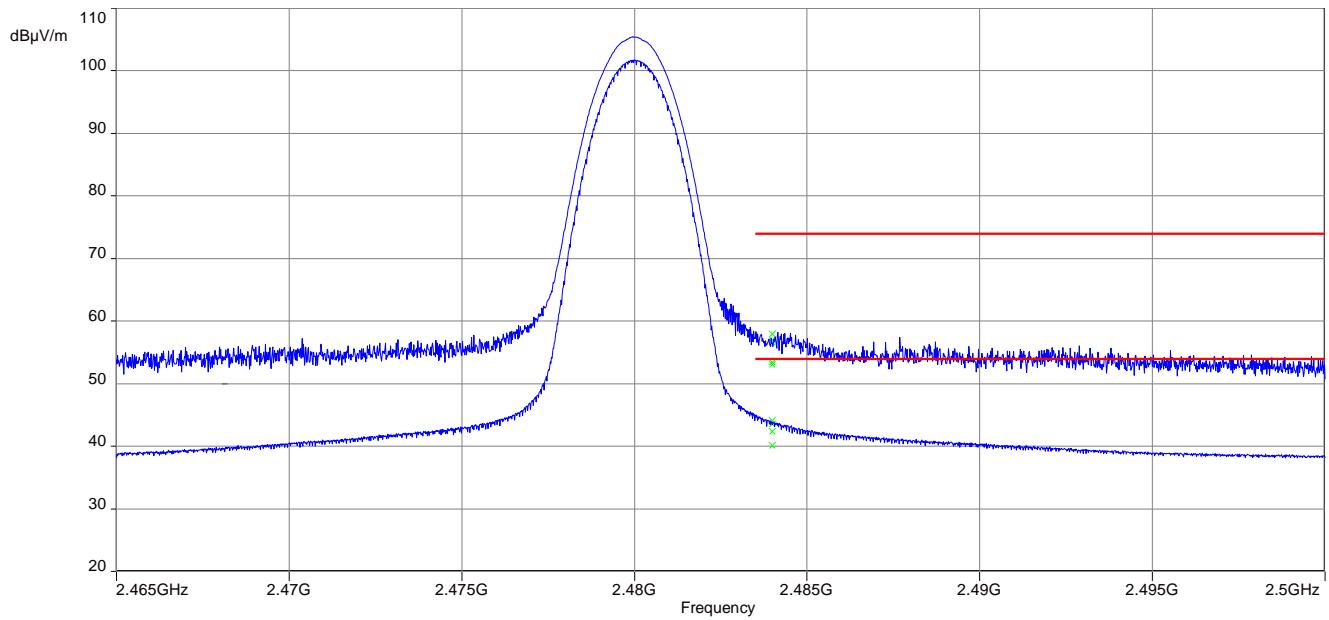
Plot 4: Upper band edge, Pi/4 DQPSK modulation, vertical & horizontal polarization



Plot 5: Lower band edge, 8 DPSK modulation, vertical & horizontal polarization



Plot 6: Upper band edge, 8 DPSK modulation, vertical & horizontal polarization



11.9 Spurious emissions conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is repeated for all modulations.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	9 kHz to 25 GHz
Trace mode	Max hold
Test setup	See sub clause 6.4 A
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
TX spurious emissions conducted	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	

Results:

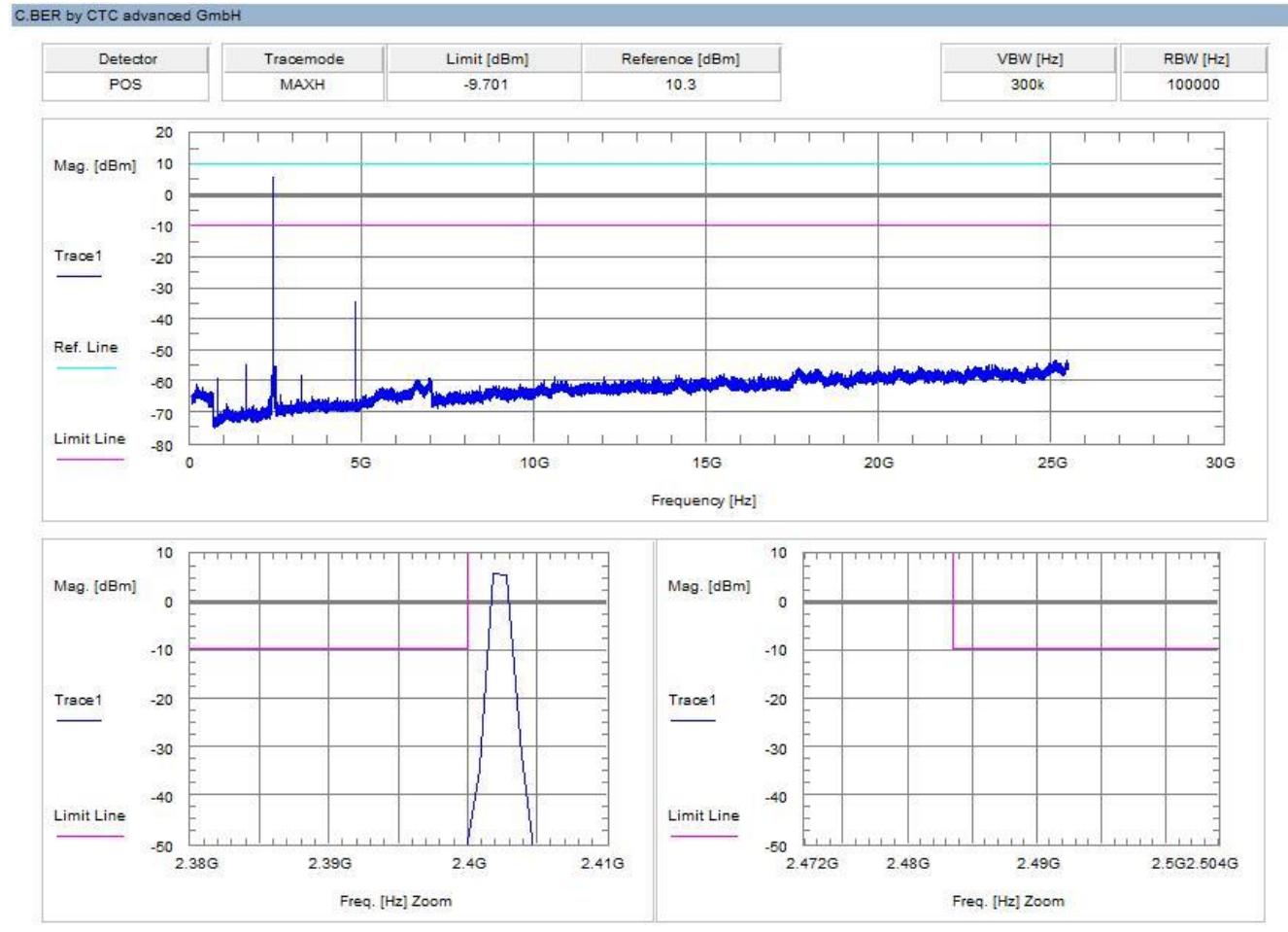
TX spurious emissions conducted					
GFSK - mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2402		10.3	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2441		9.9	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2480		10.0	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant

Results:

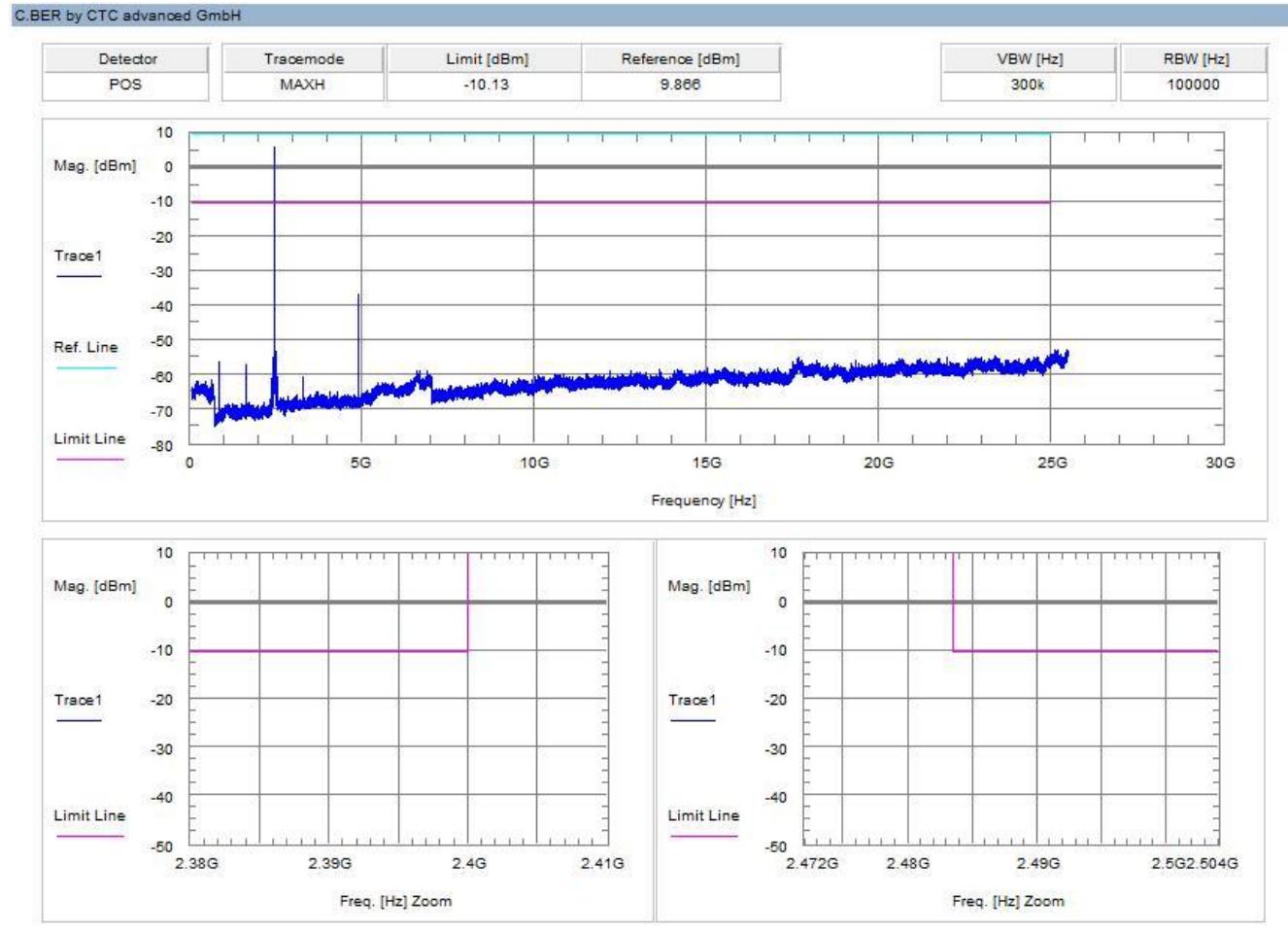
TX spurious emissions conducted					
Pi/4-DQPSK - mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2402		7.1	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2441		7.2	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2480		6.6	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant

Results:

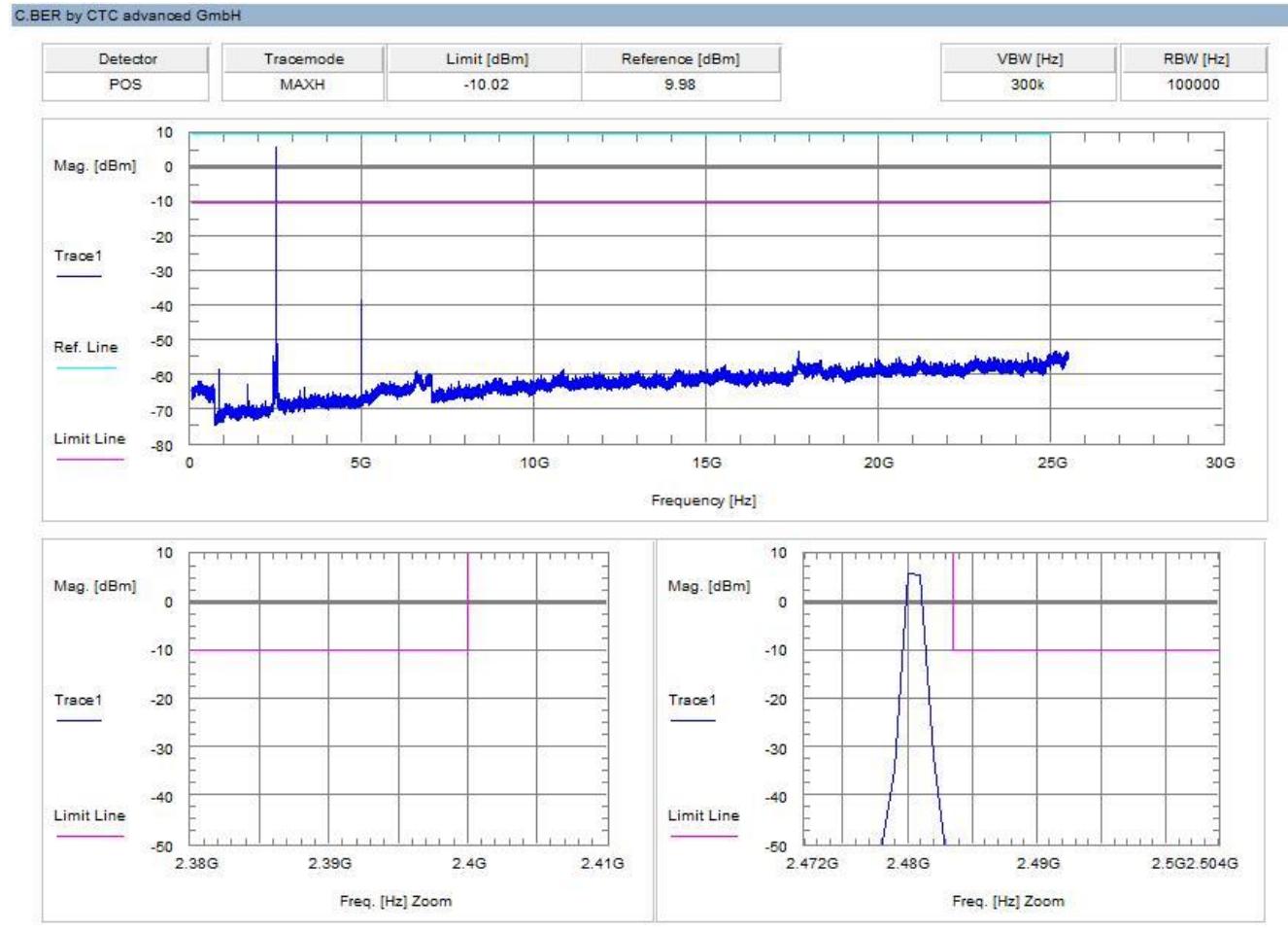
TX spurious emissions conducted 8DPSK - mode					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2402		7.1	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2441		6.5	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant
2480		6.3	30 dBm		Operating frequency
All detected emissions are below the -20 dBc criteria. Please take a look at the plot!			-20 dBc		compliant

Plots:**Plot 1: lowest channel – 2402 MHz, GFSK modulation**

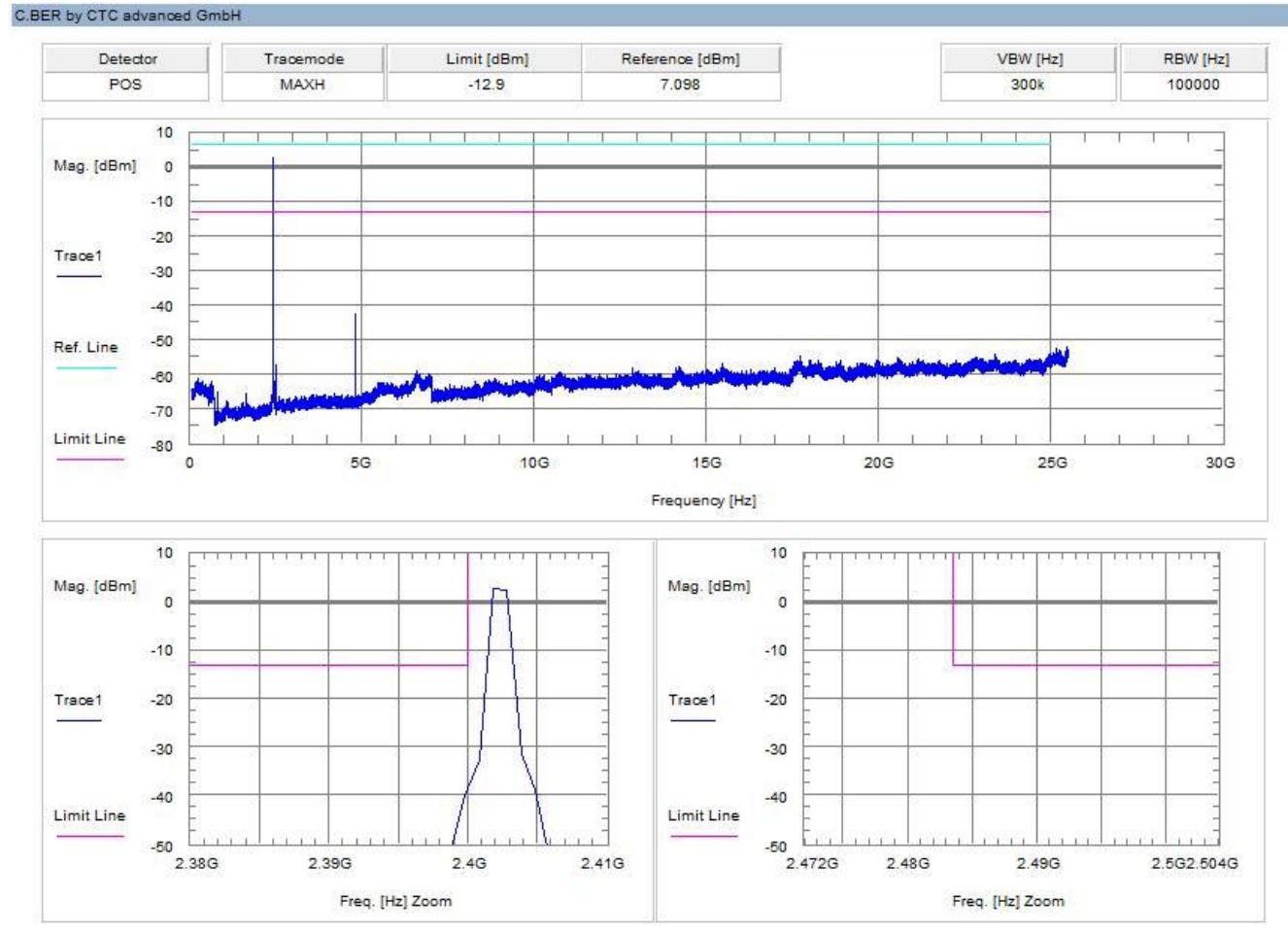
Plot 2: middle channel – 2441 MHz, GFSK modulation



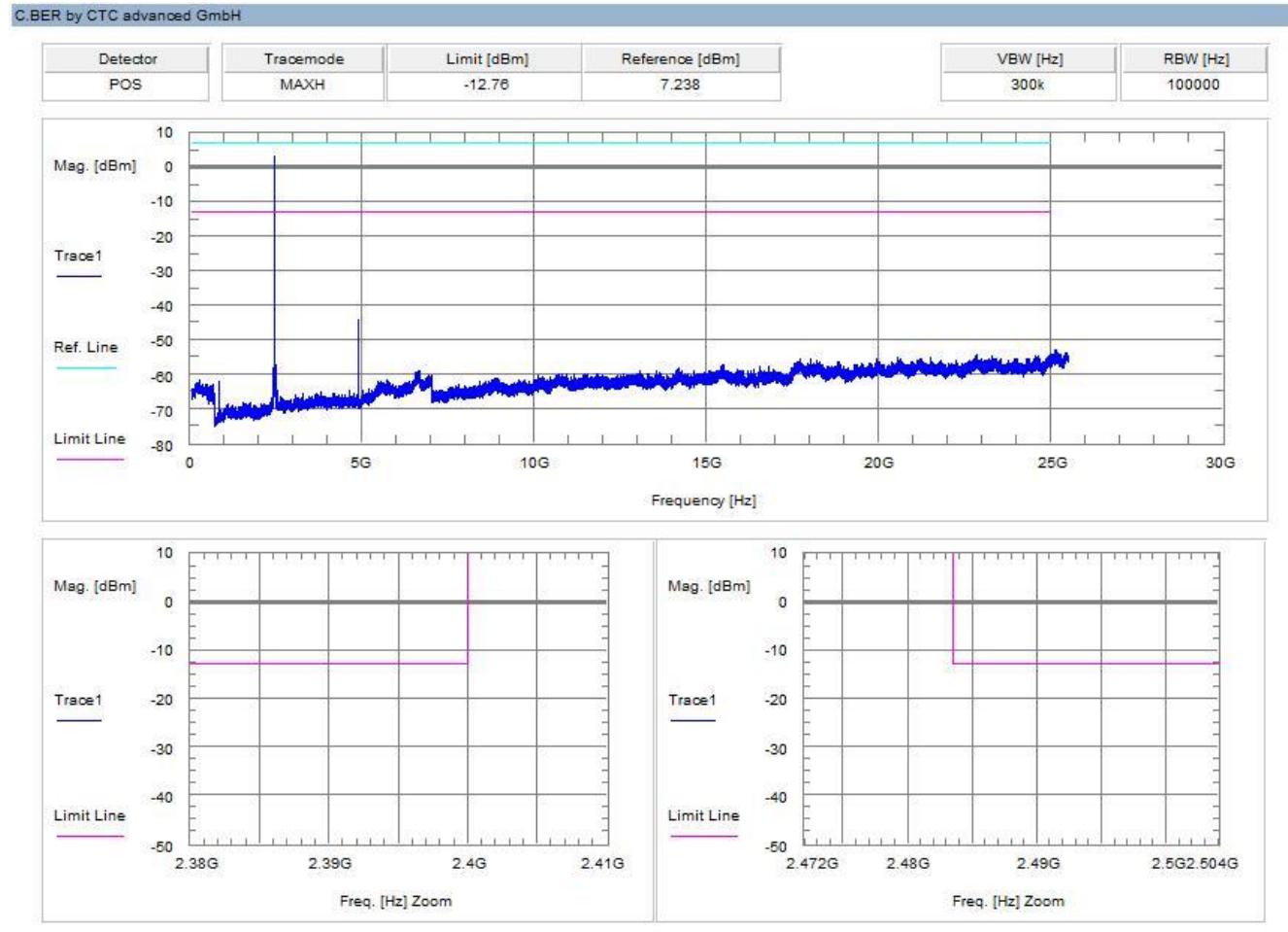
Plot 3: highest channel – 2480 MHz, GFSK modulation



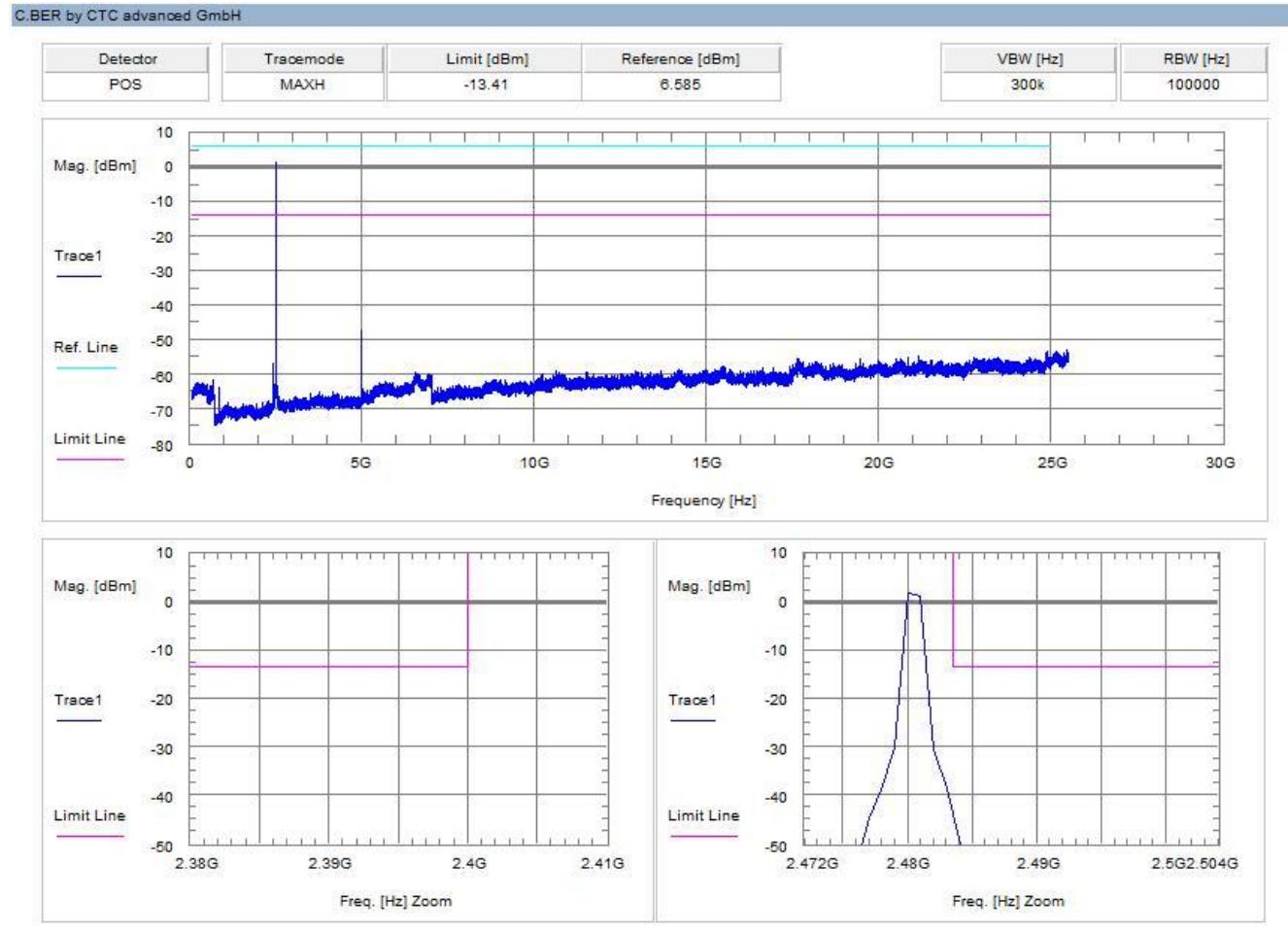
Plot 4: lowest channel – 2402 MHz, Pi / DQPSK modulation



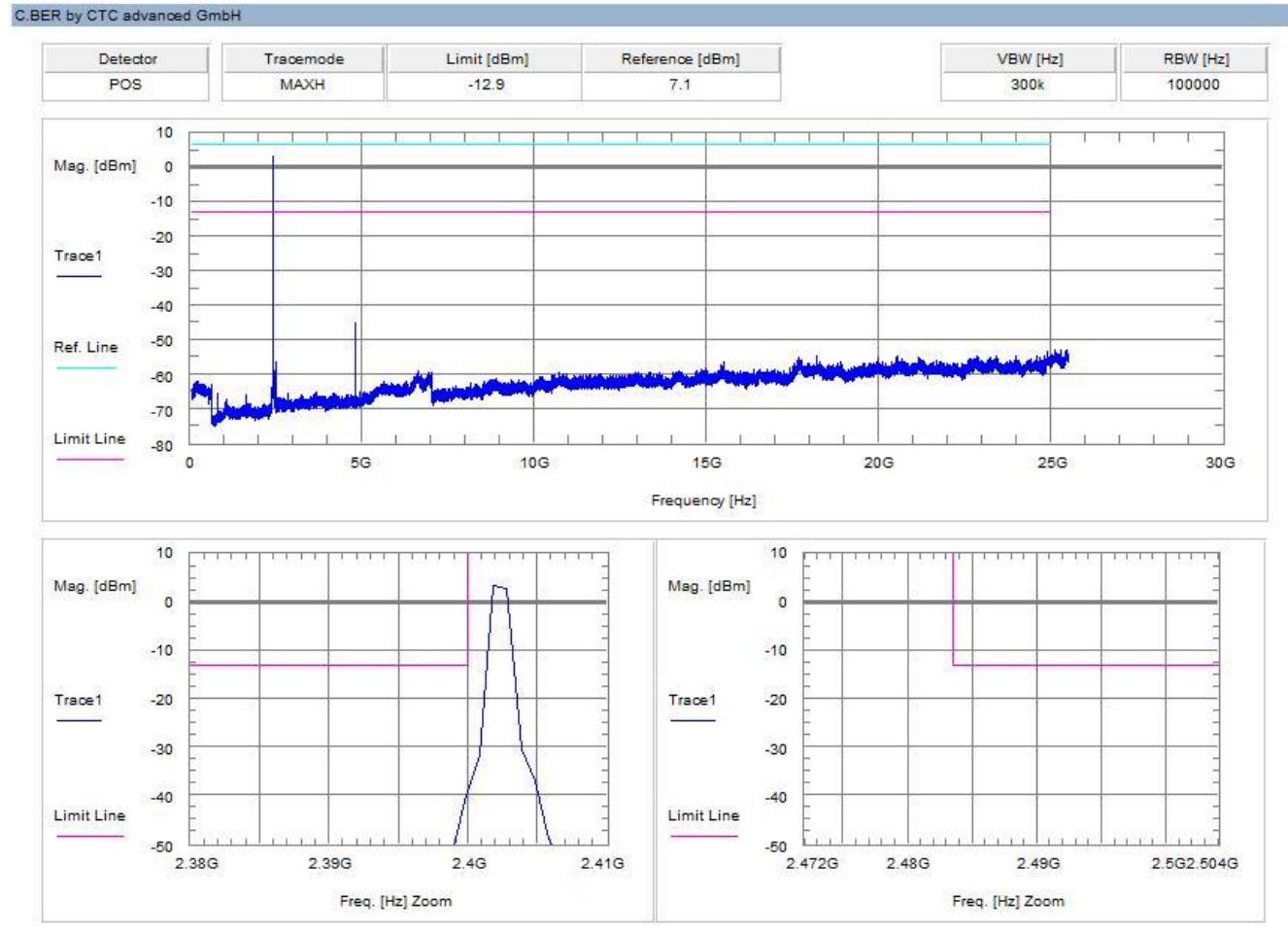
Plot 5: middle channel – 2441 MHz, Pi / DQPSK modulation



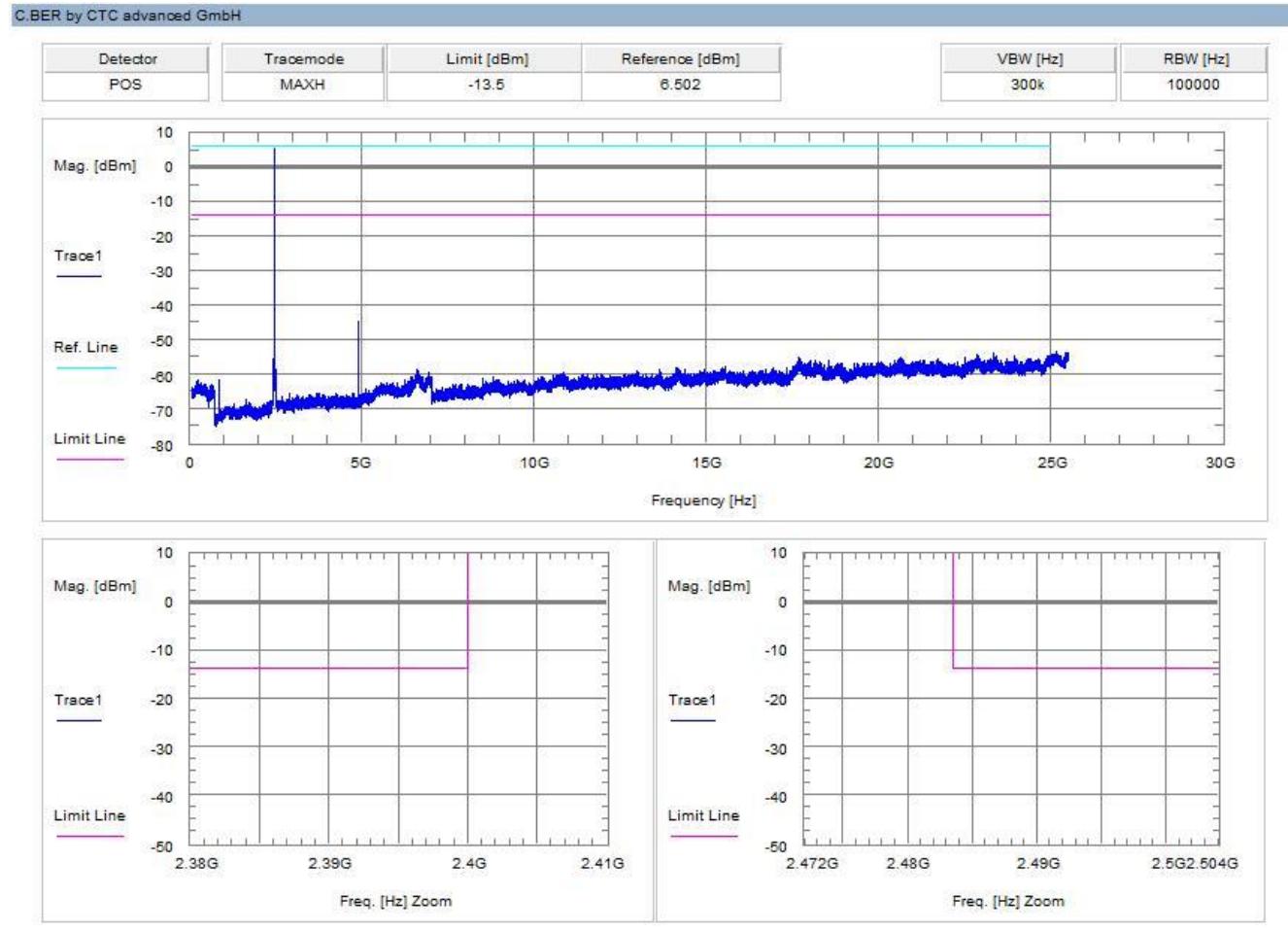
Plot 6: highest channel – 2480 MHz, Pi / DQPSK modulation



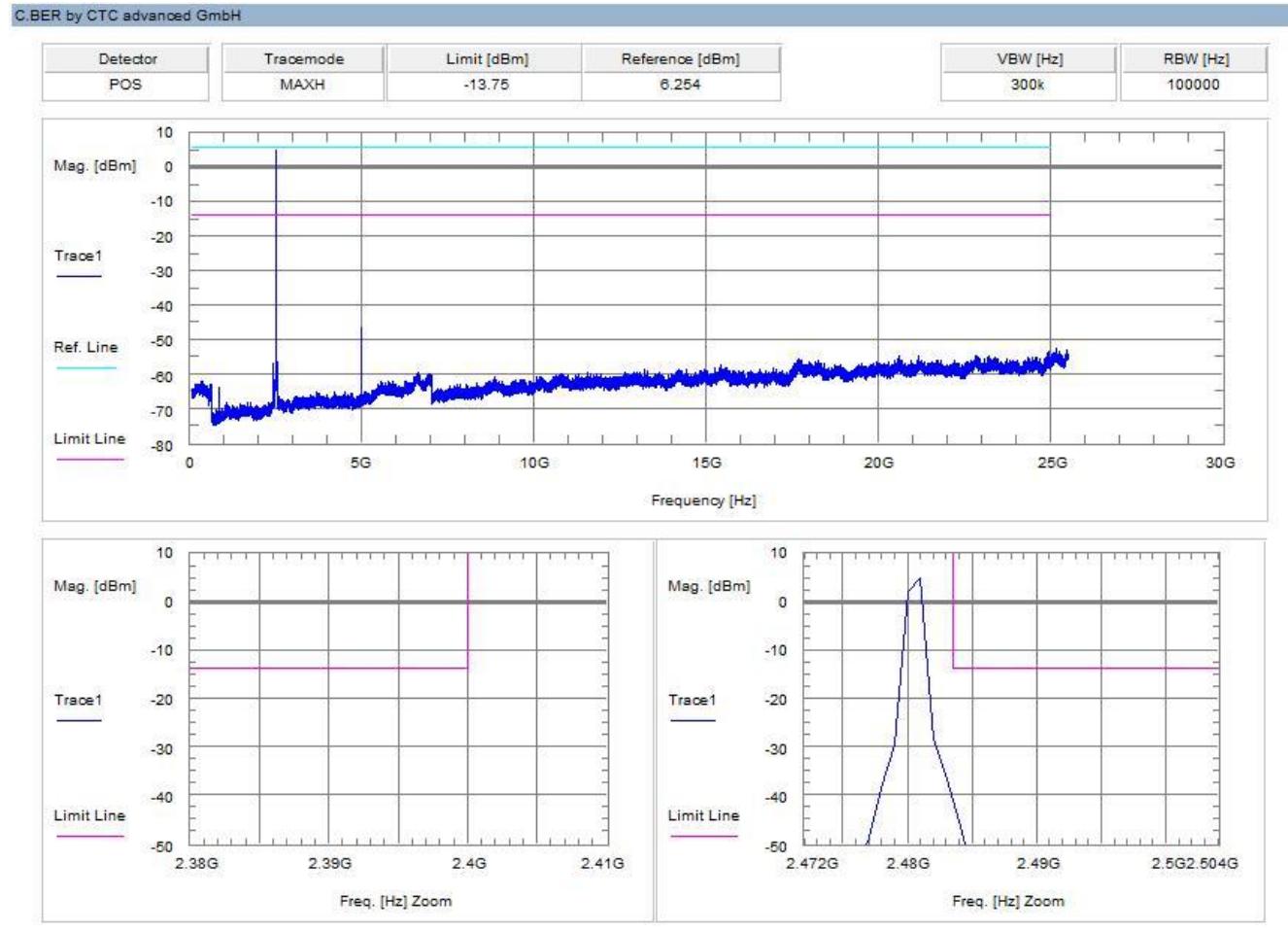
Plot 7: lowest channel – 2402 MHz, 8 DPSK modulation



Plot 8: middle channel – 2441 MHz, 8 DPSK modulation



Plot 9: highest channel – 2480 MHz, 8 DPSK modulation



11.10 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channels are 00; 39 and 78. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement parameters	
Detector	Peak / Quasi peak
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span	9 kHz to 30 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 C
Measurement uncertainty	See sub clause 8

Limits:

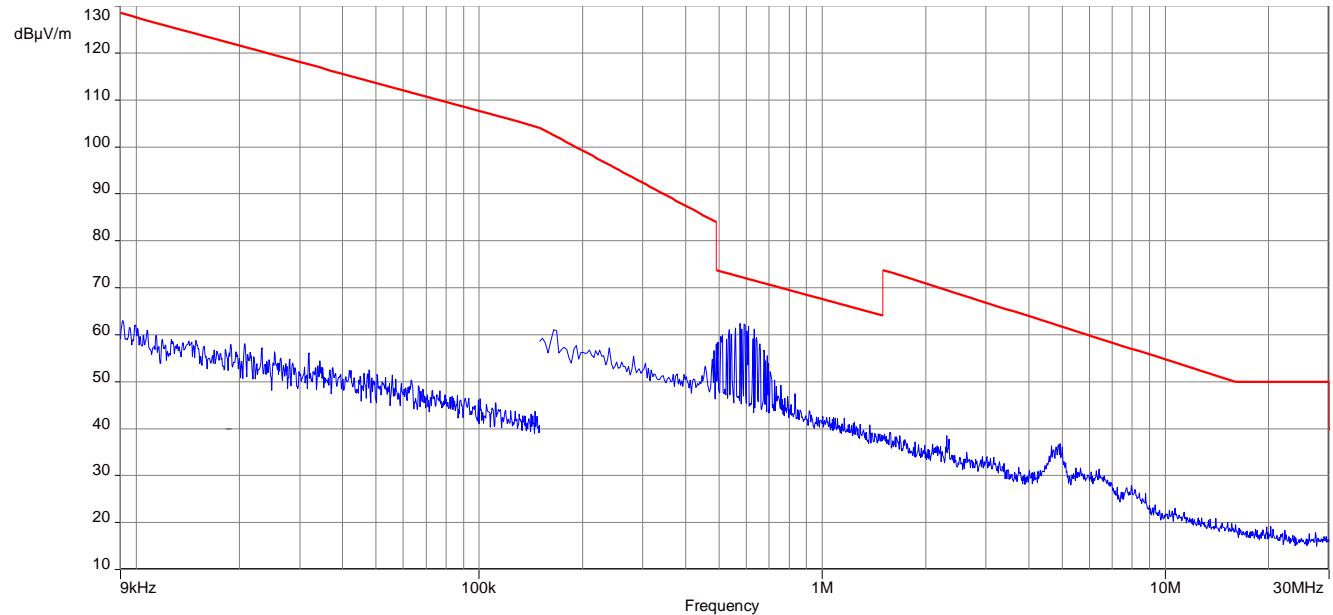
FCC	IC	
TX spurious emissions radiated below 30 MHz		
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

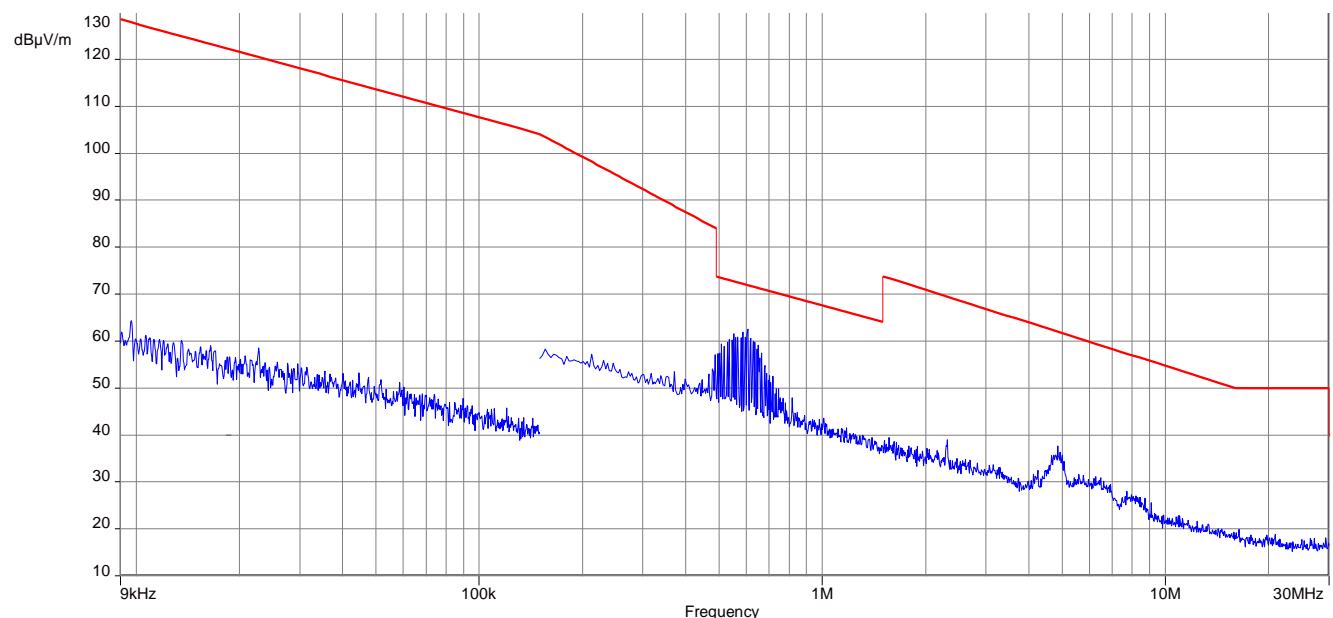
TX spurious emissions radiated below 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

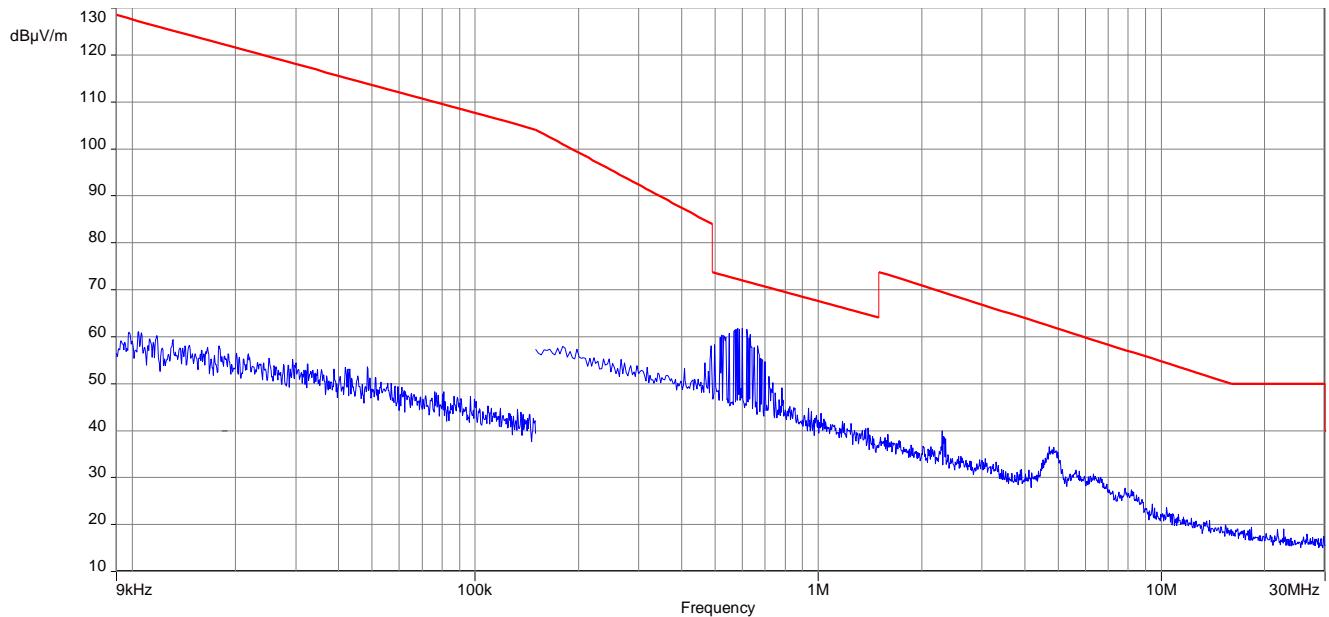
Plot 1: 9 kHz to 30 MHz, channel 00, transmit mode



Plot 2: 9 kHz to 30 MHz, channel 39, transmit mode



Plot 3: 9 kHz to 30 MHz, channel 78, transmit mode



11.11 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	120 kHz
Video bandwidth	3 x RBW
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	<input checked="" type="checkbox"/> GFSK <input type="checkbox"/> Pi/4 DQPSK <input type="checkbox"/> 8DPSK
Test setup	See sub clause 6.1 A
Measurement uncertainty	See sub clause 8

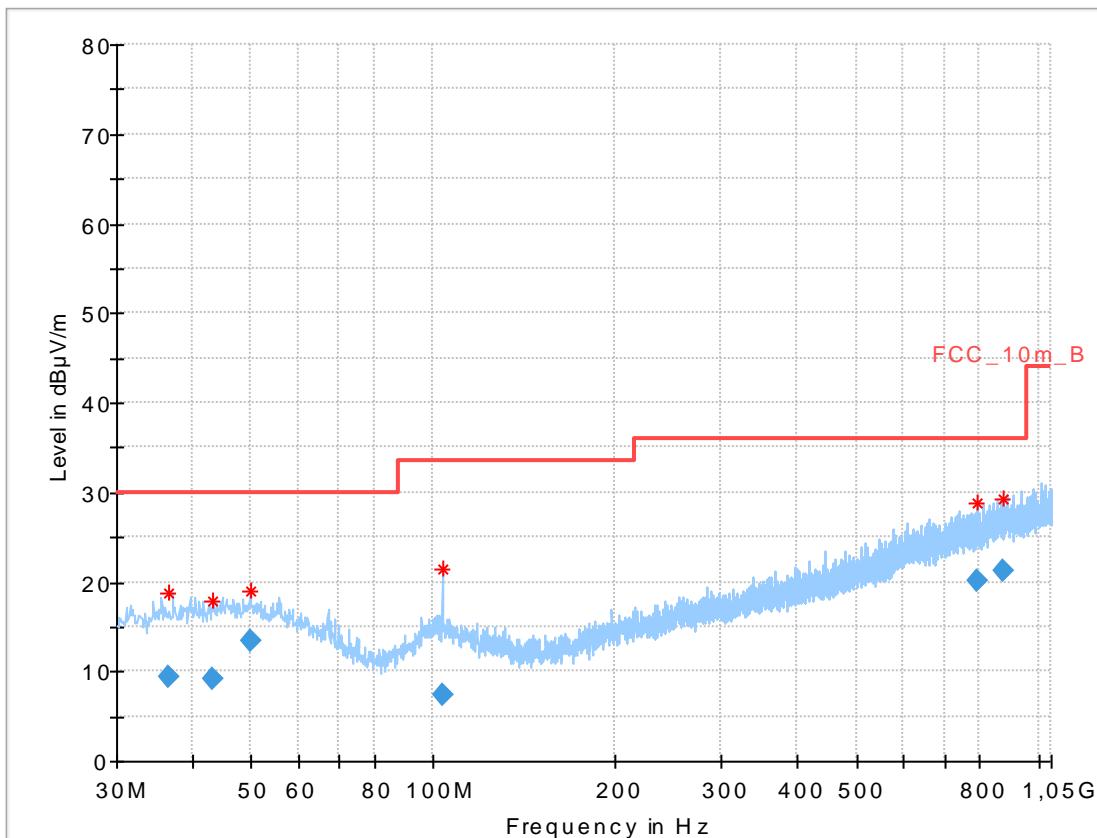
The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC	IC															
TX spurious emissions radiated																
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).																
§15.209																
<table border="1"> <thead> <tr> <th>Frequency (MHz)</th> <th>Field strength (dBμV/m)</th> <th>Measurement distance</th> </tr> </thead> <tbody> <tr> <td>30 - 88</td> <td>30.0</td> <td>10</td> </tr> <tr> <td>88 – 216</td> <td>33.5</td> <td>10</td> </tr> <tr> <td>216 – 960</td> <td>36.0</td> <td>10</td> </tr> <tr> <td>Above 960</td> <td>54.0</td> <td>3</td> </tr> </tbody> </table>		Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance	30 - 88	30.0	10	88 – 216	33.5	10	216 – 960	36.0	10	Above 960	54.0	3
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance														
30 - 88	30.0	10														
88 – 216	33.5	10														
216 – 960	36.0	10														
Above 960	54.0	3														

Plots: Transmit mode

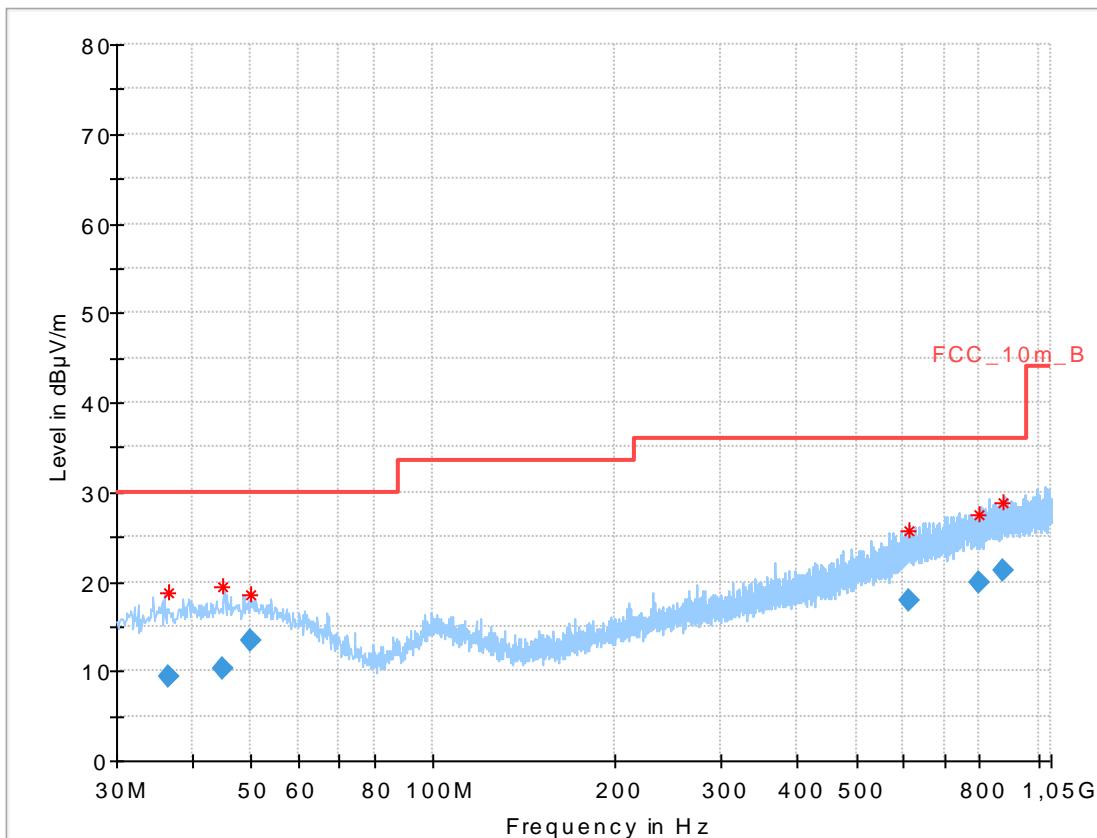
Plot 1: 30 MHz to 1 GHz, TX mode, channel 00, vertical & horizontal polarization



Final results:

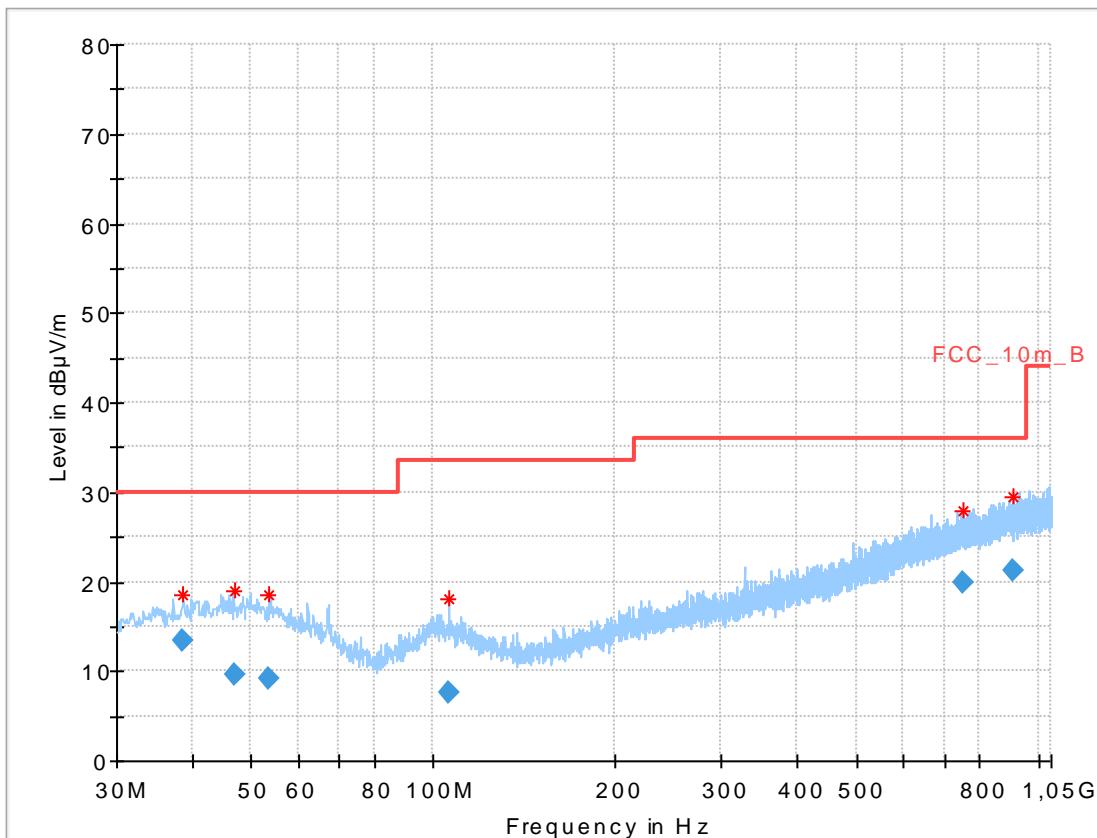
Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
36.555000	9.33	30.00	20.67	1000.0	120.000	101.0	H	100.0	12.8
43.223400	9.20	30.00	20.80	1000.0	120.000	170.0	V	261.0	13.5
49.982850	13.40	30.00	16.60	1000.0	120.000	101.0	V	81.0	13.7
103.668150	7.27	33.50	26.23	1000.0	120.000	101.0	H	170.0	11.8
791.570250	20.03	36.00	15.97	1000.0	120.000	170.0	V	190.0	22.7
877.821600	21.21	36.00	14.79	1000.0	120.000	170.0	V	-8.0	23.9

Plot 2: 30 MHz to 1 GHz, TX mode, channel 39, vertical & horizontal polarization

**Final results:**

Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
36.486600	9.39	30.00	20.61	1000.0	120.000	101.0	H	80.0	12.8
45.075600	10.27	30.00	19.73	1000.0	120.000	101.0	H	261.0	13.6
49.973850	13.38	30.00	16.62	1000.0	120.000	101.0	V	262.0	13.7
611.841000	17.96	36.00	18.04	1000.0	120.000	170.0	V	-10.0	20.8
800.968800	19.91	36.00	16.09	1000.0	120.000	98.0	V	100.0	22.8
876.161400	21.24	36.00	14.76	1000.0	120.000	170.0	V	260.0	23.9

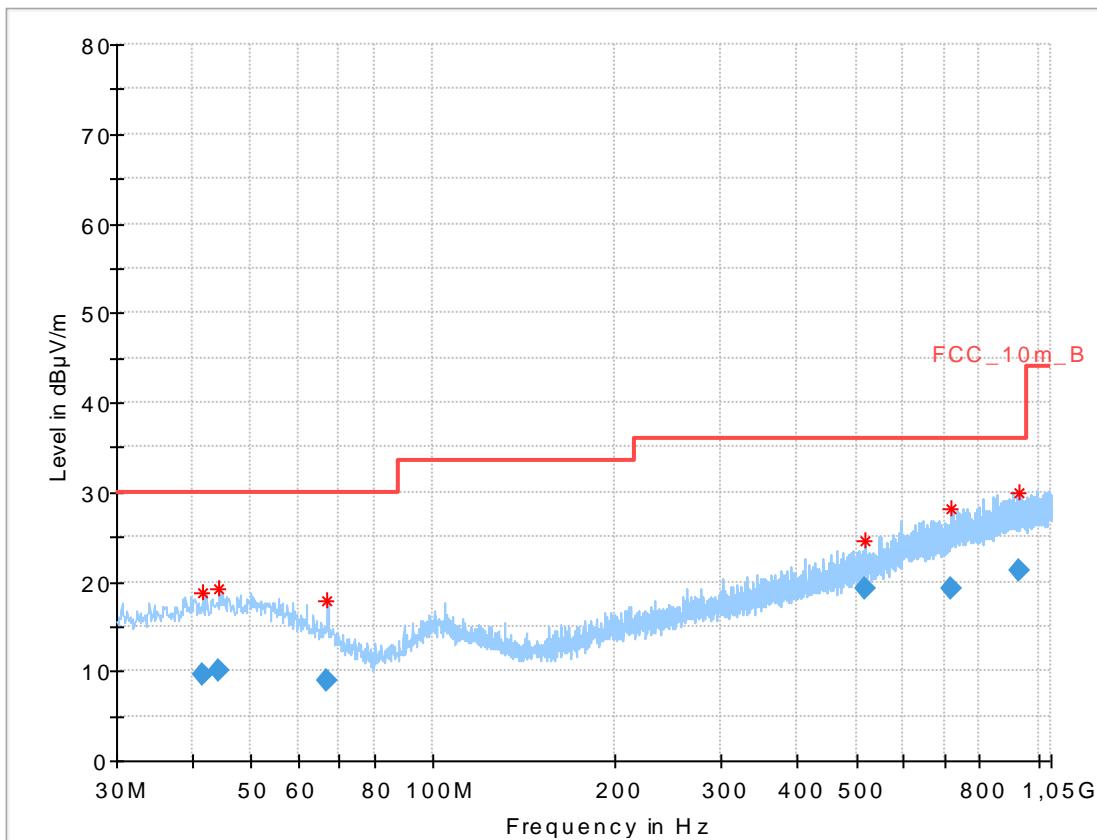
Plot 3: 30 MHz to 1 GHz, TX mode, channel 78, vertical & horizontal polarization

**Final results:**

Frequency (MHz)	QuasiPeak (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
38.684850	13.49	30.00	16.51	1000.0	120.000	101.0	V	280.0	13.1
46.933200	9.71	30.00	20.29	1000.0	120.000	101.0	V	170.0	13.7
53.623200	9.19	30.00	20.81	1000.0	120.000	101.0	V	82.0	13.3
105.929100	7.70	33.50	25.80	1000.0	120.000	170.0	V	190.0	11.5
749.284350	19.84	36.00	16.16	1000.0	120.000	170.0	H	280.0	22.7
905.884200	21.20	36.00	14.80	1000.0	120.000	170.0	V	-10.0	24.2

Plots: Receiver mode

Plot 1: 30 MHz to 1 GHz, RX / idle – mode, vertical & horizontal polarization



Final results:

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.550900	9.64	30.00	20.36	1000.0	120.000	98.0	H	248.0	13.3
44.146500	10.14	30.00	19.86	1000.0	120.000	101.0	V	255.0	13.6
66.742350	9.01	30.00	20.99	1000.0	120.000	101.0	H	8.0	10.4
515.389200	19.28	36.00	16.72	1000.0	120.000	178.0	V	230.0	18.9
719.354100	19.27	36.00	16.73	1000.0	120.000	185.0	V	300.0	22.0
928.433550	21.23	36.00	14.77	1000.0	120.000	185.0	H	353.0	24.3

11.12 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 00, channel 39 and channel 78. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 26 GHz
Trace mode	Max hold
Measured modulation	<input checked="" type="checkbox"/> GFSK <input type="checkbox"/> Pi/4 DQPSK <input type="checkbox"/> 8DPSK
Test setup	See sub clause 6.2 A (1 GHz - 18 GHz) See sub clause 6.3 A (18 GHz - 26 GHz)
Measurement uncertainty	See sub clause 8

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC	IC	
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dB μ V/m)	Measurement distance
Above 960	54.0	3

Results: Transmitter mode

TX spurious emissions radiated [dB μ V/m]								
2402 MHz			2441 MHz			2480 MHz		
F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.								
4803.6	Peak	65.1	-/-	Peak	-/-	-/-	Peak	-/-
	AVG*	43.1		AVG*	-/-		AVG*	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG*	-/-		AVG*	-/-		AVG*	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG*	-/-		AVG*	-/-		AVG*	-/-

*) Average emission adjusting factor:

$$F = 20 * \log (\text{dwell time} / 100 \text{ ms})$$

The dwell time of the longest possible Bluetooth transmission (DH5-packet) is **11.3 ms**

In a period of 100 ms, we have a maximum of 1 transmission and that implies a correction factor for spurious measurement emissions:

$$F = 20 * \log (1 * 367.4 / 100) = -18.9 \text{ dB}$$

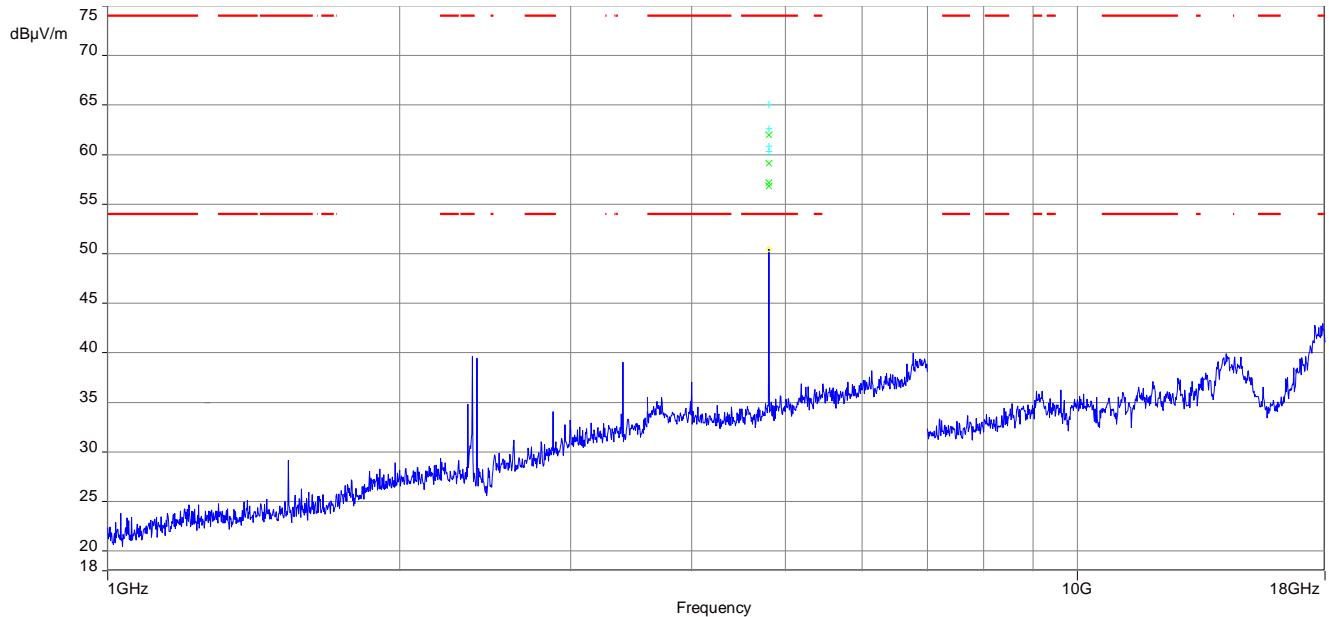
Results: Receiver mode

RX spurious emissions radiated [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
All detected emissions are more than 20 dB below the limit.		
-/-	Peak	-/-
	AVG	-/-

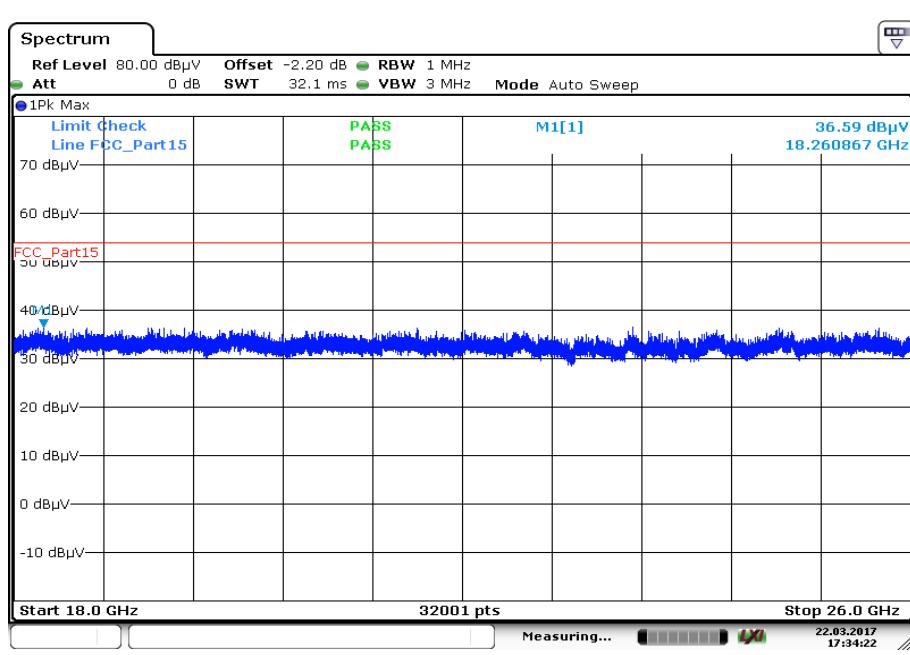
Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

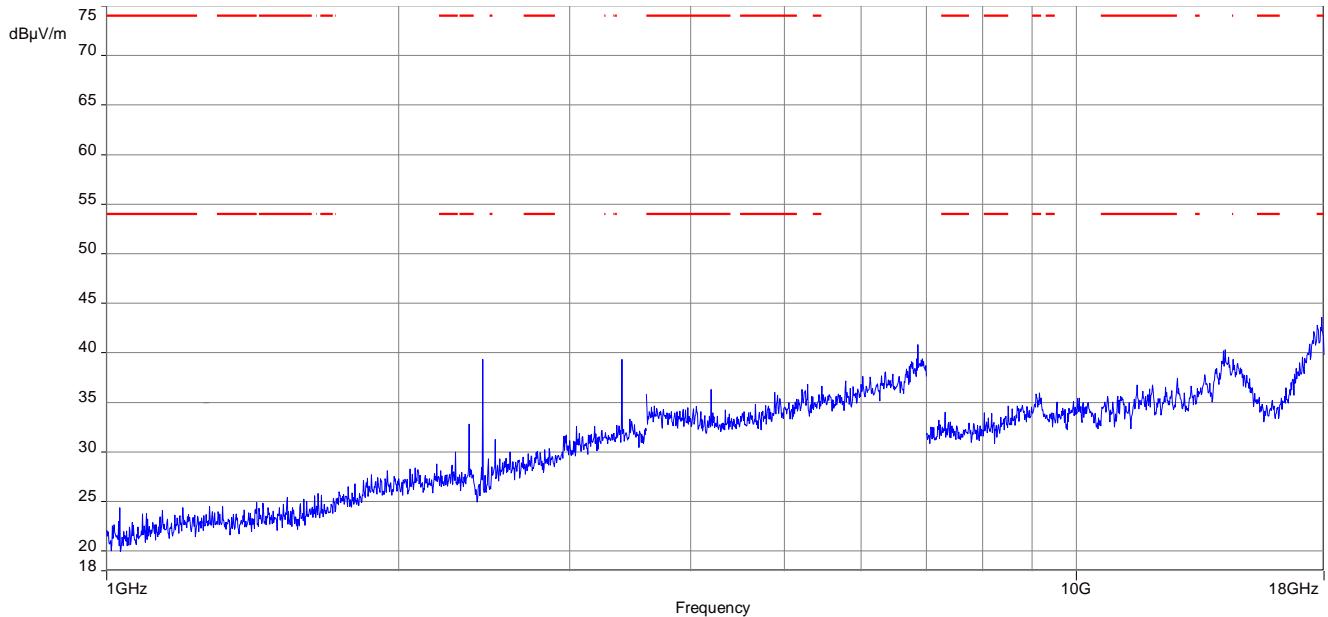
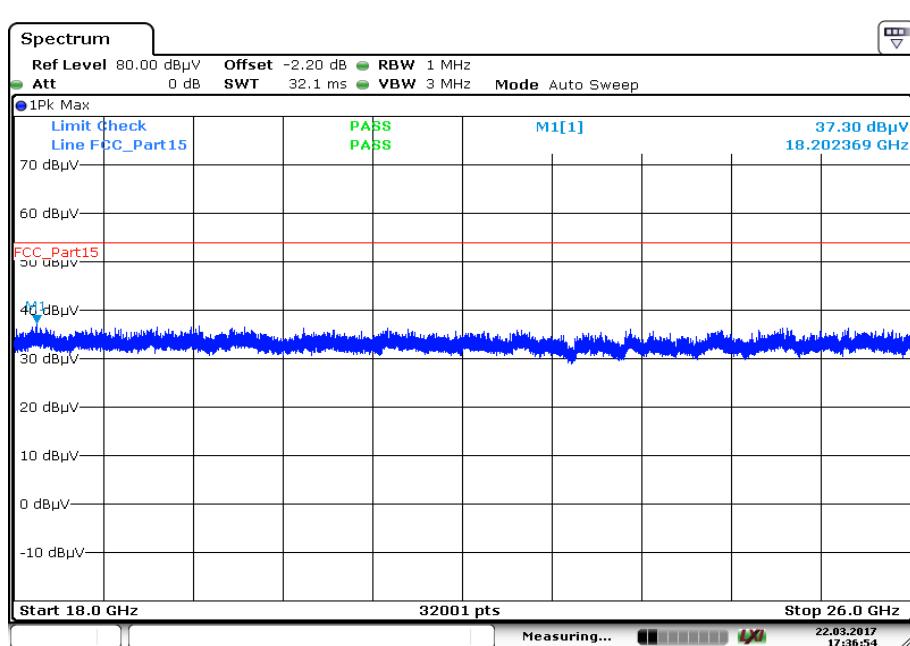
Plots: Transmitter mode

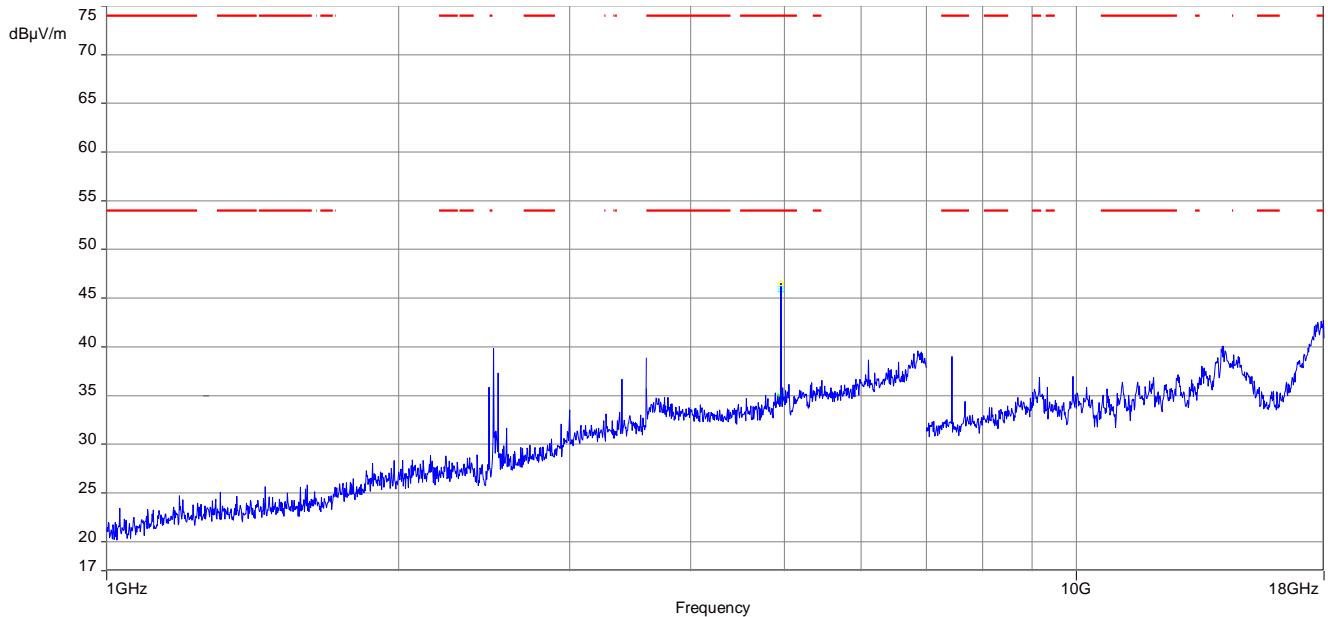
Plot 1: 1 GHz to 18 GHz, TX mode, channel 00, vertical & horizontal polarization



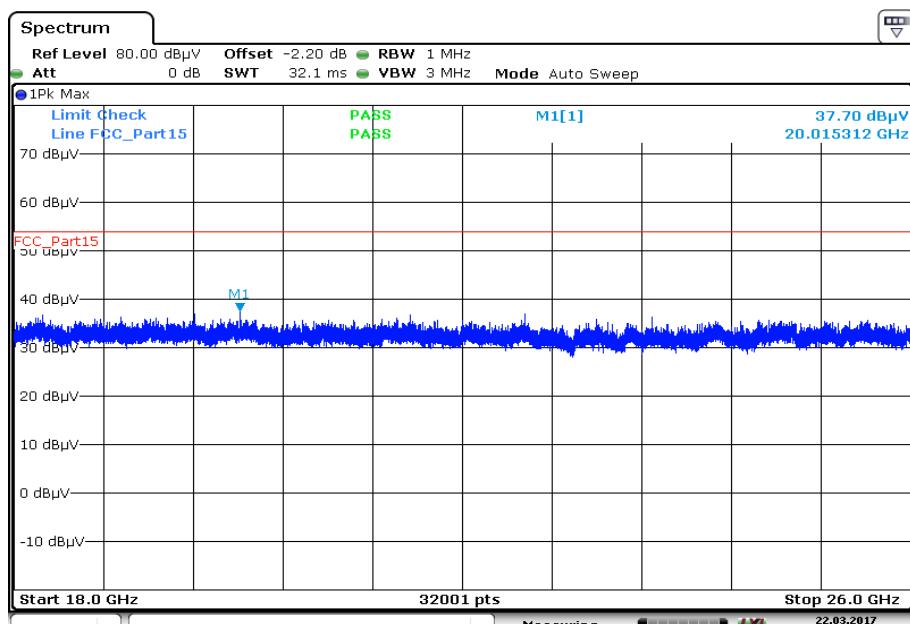
Plot 4: 18 GHz to 26 GHz, TX mode, channel 00, vertical & horizontal polarization



Plot 5: 1 GHz to 18 GHz, TX mode, channel 39, vertical & horizontal polarization**Plot 8:** 18 GHz to 26 GHz, TX mode, channel 39, vertical & horizontal polarization

Plot 9: 1 GHz to 18 GHz, TX mode, channel 78, vertical & horizontal polarization

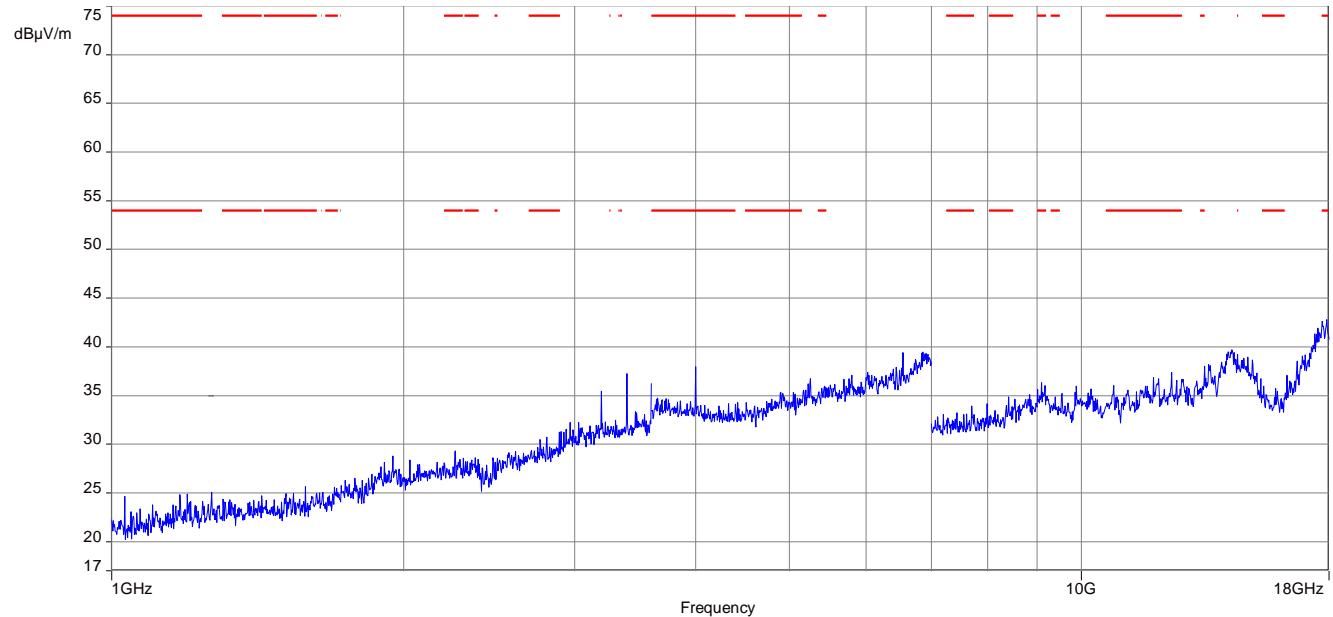
The carrier signal is notched with a 2.4 GHz band rejection filter.

Plot 12: 18 GHz to 26 GHz, TX mode, channel 78, vertical & horizontal polarization

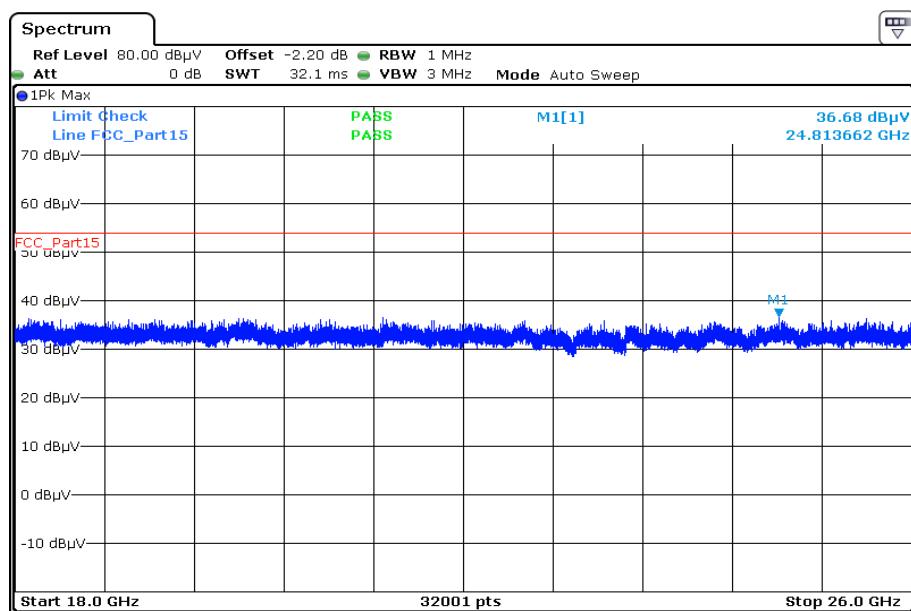
Date: 22.MAR.2017 17:38:15

Plots: Receiver mode

Plot 1: 1 GHz to 18 GHz, RX / idle – mode, vertical & horizontal polarization



Plot 4: 18 GHz to 26 GHz, RX / idle – mode, vertical & horizontal polarization



Date: 22.MAR.2017 17:39:04

11.13 Spurious emissions conducted below 30 MHz (AC conducted)

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channel is channel 39. This measurement is representative for all channels and modes. If critical peaks are found channel 00 and channel 78 will be measured too. The measurement is performed in the mode with the highest output power. Both power lines, phase and neutral line, are measured. Found peaks are remeasured with average and quasi peak detection to show compliance to the limits.

Measurement parameters	
Detector	Peak - Quasi peak / average
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span	9 kHz to 30 MHz
Trace mode	Max hold
Test setup	See sub clause 6.5. A
Measurement uncertainty	See sub clause 8

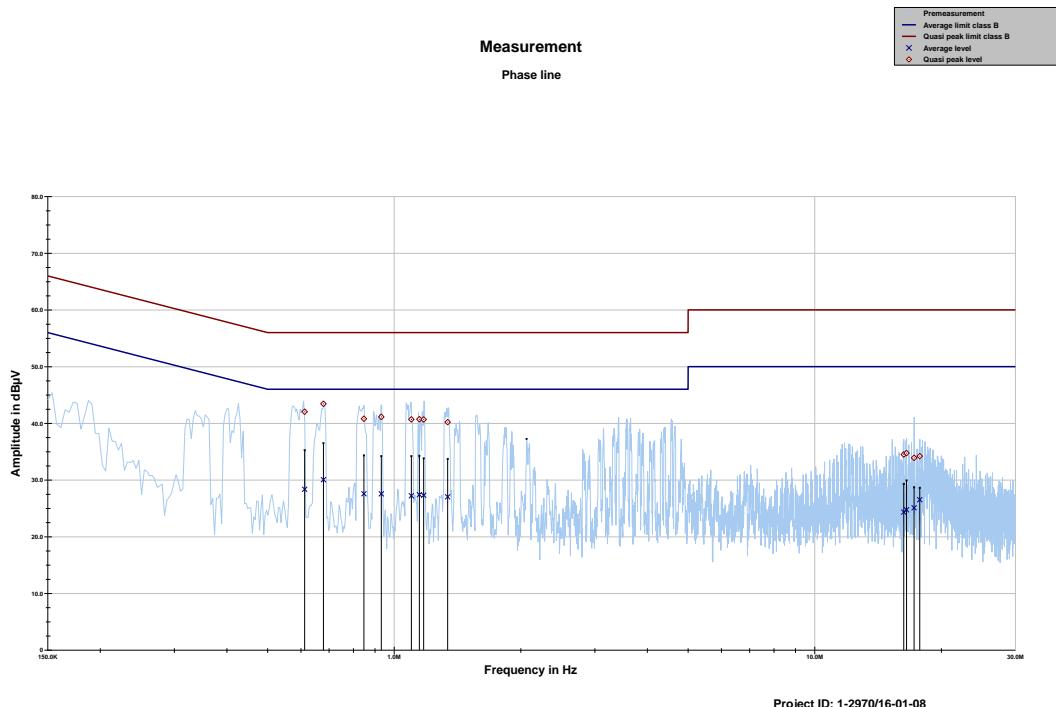
Limits:

FCC	IC	
TX spurious emissions conducted < 30 MHz		
Frequency (MHz)	Quasi-peak (dB μ V/m)	Average (dB μ V/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

*Decreases with the logarithm of the frequency

Results:

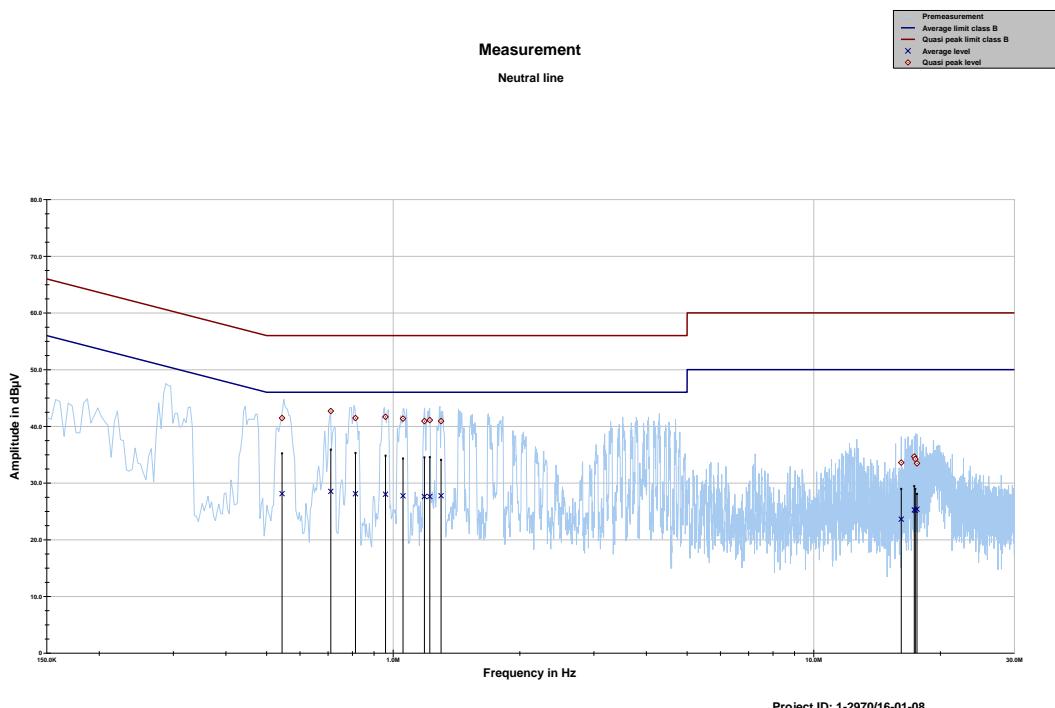
Spurious emissions conducted < 30 MHz [dB μ V/m]		
F [MHz]	Detector	Level [dB μ V/m]
No emissions detected		

Plots:**Plot 1:** 150 kHz to 30 MHz, phase line

Project ID: 1-2970/16-01-08

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.612466	42.04	13.96	56.000	28.36	17.64	46.000
0.678829	43.44	12.56	56.000	30.06	15.94	46.000
0.847132	40.81	15.19	56.000	27.58	18.42	46.000
0.931748	41.14	14.86	56.000	27.56	18.44	46.000
1.098542	40.68	15.32	56.000	27.22	18.78	46.000
1.147725	40.73	15.27	56.000	27.41	18.59	46.000
1.174775	40.68	15.32	56.000	27.32	18.68	46.000
1.339907	40.21	15.79	56.000	27.03	18.97	46.000
16.282048	34.51	25.49	60.000	24.35	25.65	50.000
16.534299	34.75	25.25	60.000	24.73	25.27	50.000
17.230804	33.91	26.09	60.000	25.11	24.89	50.000
17.773301	34.21	25.79	60.000	26.52	23.48	50.000

Plot 2: 150 kHz to 30 MHz, neutral line



Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.544159	41.47	14.53	56.000	28.11	17.89	46.000
0.710759	42.70	13.30	56.000	28.52	17.48	46.000
0.813534	41.45	14.55	56.000	28.11	17.89	46.000
0.959032	41.67	14.33	56.000	28.03	17.97	46.000
1.055167	41.35	14.65	56.000	27.74	18.26	46.000
1.186400	40.93	15.07	56.000	27.61	18.39	46.000
1.222142	41.10	14.90	56.000	27.63	18.37	46.000
1.299486	40.92	15.08	56.000	27.76	18.24	46.000
16.146618	33.61	26.39	60.000	23.63	26.37	50.000
17.343449	34.66	25.34	60.000	25.26	24.74	50.000
17.445771	34.24	25.76	60.000	25.17	24.83	50.000
17.605976	33.48	26.52	60.000	25.39	24.61	50.000

12 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2017-04-12

Annex B Further information

Glossary

AVG	- Average
DUT	- Device under test
EMC	- Electromagnetic Compatibility
EN	- European Standard
EUT	- Equipment under test
ETSI	- European Telecommunications Standard Institute
FCC	- Federal Communication Commission
FCC ID	- Company Identifier at FCC
HW	- Hardware
IC	- Industry Canada
Inv. No.	- Inventory number
N/A	- Not applicable
PP	- Positive peak
QP	- Quasi peak
S/N	- Serial number
SW	- Software
PMN	- Product marketing name
HMN	- Host marketing name
HVIN	- Hardware version identification number
FVIN	- Firmware version identification number
OBW	Occupied Bandwidth
OC	Operating Channel
OCW	Operating Channel Bandwidth
OOB	Out Of Band

Annex C Accreditation Certificate

first page



Deutsche Akkreditierungsstelle GmbH

Berechene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CTC advanced GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen
durchzuführen:

Funk
Mobilfunk (GSM / DCS) + OTA
Elektromagnetische Verträglichkeit (EMV)
Produktsicherheit
SAR / EMF
Umwelt
Smart Card Technology
Bluetooth®
Automotive
Wi-Fi-Services
Kanadische Anforderungen
US-Anforderungen
Akustik
Near Field Communication (NFC)

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 25.11.2016 mit der
Akkreditierungsnummer D-PL-12076-01 und ist gültig bis 17.01.2018. Sie besteht aus diesem Deckblatt,
der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 63 Seiten.

Registrierungsnummer der Urkunde: D-PL-12076-01-01

Frankfurt, 25.11.2016
Siehe Hinweise auf der Rückseite

Im Auftrag Dipl.-Ing. Ulf Ralf Egner
Abteilungsteuer

last page

Deutsche Akkreditierungsstelle GmbH

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38116 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen
Zustimmung der Deutsche Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate
Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in
unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt,
die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom
31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments
und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung
im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung
der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und
der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen
erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
EA: www.european-accreditation.org
ILAC: www.ilac.org
IAF: www.iaf.nu

Note:

The current certificate including annex can be received on request.